Freescale Semiconductor

Data Sheet: Technical Data

Document Number: DSP56367 Rev. 2.1, 1/2007

DSP56367

24-Bit Audio Digital Signal Processor

1 Overview

This document briefly describes the DSP56367 24-bit digital signal processor (DSP). The DSP56367 is a member of the DSP56300 family of programmable CMOS DSPs. The DSP56367 is targeted to applications that require digital audio compression/decompression, sound field processing, acoustic equalization and other digital audio algorithms. The DSP56367 offers 150 million instructions per second (MIPS) using an internal 150 MHz clock at 1.8 V and 100 million instructions per second (MIPS) using an internal 150 MHz clock at 1.5 V.

Contents

1	Overview 1-1
2	Signal/Connection Descriptions 2-1
3	Specifications
4	Packaging 4-1
5	Design Considerations
Α	Power Consumption Benchmark A-1

This document contains information on a new product. Specifications and information herein are subject to change without notice.

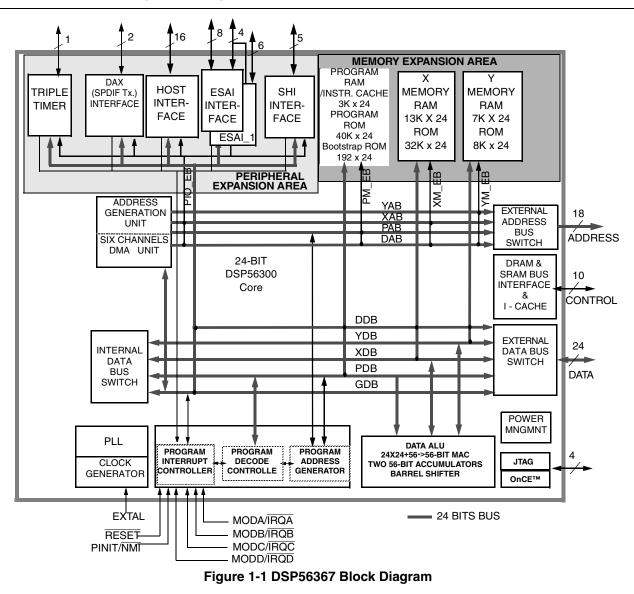
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Overview

Data Sheet Conventions				
This data sheet uses	the following conventions:			
OVERBAR	Used to indicate a signal that is active when pulled low (For example, the $\overline{\text{RESET}}$ pin is active when low.)			
"asserted"	Means that a high true (active high) signal is high or that a low true (active low) signal is low			
"deasserted"	Means that a high true (active high) signal is low or that a low true (active low) signal is high			
Examples:	Signal/Symbol Logic State Signal State Voltage		Voltage*	
	PIN	True	Asserted	V _{IL} / V _{OL}
	PIN	False	Deasserted	V _{IH} / V _{OH}
	PIN	True	Asserted	V _{IH} / V _{OH}
	PIN	False	Deasserted	V _{IL} / V _{OL}

Note:*Values for V_{IL}, V_{OL}, V_{IH}, and V_{OH} are defined by individual product specifications.



1.1 Features

Core features are described fully in the DSP56300 Family Manual.

1.2 DSP56300 modular chassis

- 150 Million Instructions Per Second (MIPS) with a 150 MHz clock at internal logic supply (QVCCL) of 1.8V.
- 100 Million Instructions Per Second (MIPS) with a 100 MHz clock at internal logic supply (QVCCL) of 1.5V.
- Object Code Compatible with the 56K core.
- Data ALU with a 24 × 24 bit multiplier-accumulator and a 56-bit barrel shifter. 16-bit arithmetic support.
- Program Control with position independent code support and instruction cache support.
- Six-channel DMA controller.
- PLL based clocking with a wide range of frequency multiplications (1 to 4096), predivider factors (1 to 16) and power saving clock divider (2ⁱ: i=0 to 7). Reduces clock noise.
- Internal address tracing support and OnCE[™] for Hardware/Software debugging.
- JTAG port.
- Very low-power CMOS design, fully static design with operating frequencies down to DC.
- STOP and WAIT low-power standby modes.

1.3 On-chip Memory Configuration

- $7K \times 24$ Bit Y-Data RAM and $8K \times 24$ Bit Y-Data ROM.
- $13K \times 24$ Bit X-Data RAM and $32K \times 24$ Bit X-Data ROM.
- $40K \times 24$ Bit Program ROM.
- $3K \times 24$ Bit Program RAM and 192x24 Bit Bootstrap ROM. 1K of Program RAM may be used as Instruction Cache or for Program ROM patching.
- $2K \times 24$ Bit from Y Data RAM and $5K \times 24$ Bit from X Data RAM can be switched to Program RAM resulting in up to $10K \times 24$ Bit of Program RAM.

1.4 Off-chip memory expansion

- External Memory Expansion Port.
- Off-chip expansion up to two 16M x 24-bit word of Data memory.
- Off-chip expansion up to 16M x 24-bit word of Program memory.
- Simultaneous glueless interface to SRAM and DRAM.

1.5 Peripheral modules

• Serial Audio Interface (ESAI): up to 4 receivers and up to 6 transmitters, master or slave. I²S, Sony, AC97, network and other programmable protocols.

DSP56367 Technical Data, Rev. 2.1

- Serial Audio Interface I(ESAI_1): up to 4 receivers and up to 6 transmitters, master or slave. I²S, Sony, AC97, network and other programmable protocols The ESAI_1 shares four of the data pins with ESAI, and ESAI_1 does NOT support HCKR and HCKT (high frequency clocks)
- Serial Host Interface (SHI): SPI and I²C protocols, multi master capability, 10-word receive FIFO, support for 8, 16 and 24-bit words.
- Byte-wide parallel Host Interface (HDI08) with DMA support.
- Triple Timer module (TEC).
- Digital Audio Transmitter (DAX): 1 serial transmitter capable of supporting the SPDIF, IEC958, CP-340 and AES/EBU digital audio formats.
- Pins of unused peripherals (except SHI) may be programmed as GPIO lines.

1.6 144-pin plastic LQFP package

1.7 Documentation

Table 1-1 lists the documents that provide a complete description of the DSP56367 and are required to design properly with the part. Documentation is available from a local Freescale distributor, a Freescale semiconductor sales office, a Freescale Literature Distribution Center, or through the Freescale DSP home page on the Internet (the source for the latest information).

Document Name	Description	Order Number
DSP56300 Family Manual	Detailed description of the 56000-family architecture and the 24-bit core processor and instruction set	DSP56300FM
DSP56367 Product Brief	Brief description of the chip	DSP56367P
DSP56367 User's Manual	DSP56367 User's Manual	DSP56367UM
DSP56367 Technical Data Sheet (this document)	Electrical and timing specifications; pin and package descriptions	DSP56367
IBIS Model	Input Output Buffer Information Specification	For software or simulation models, contact sales or go to www.freescale.com.

Table 1-1 DSP56367 Documentation

2 Signal/Connection Descriptions

2.1 Signal Groupings

The input and output signals of the DSP56367 are organized into functional groups, which are listed in Table 2-1 and illustrated in Figure 2-1.

The DSP56367 is operated from a 1.8V supply; however, some of the inputs can tolerate 3.3V. A special notice for this feature is added to the signal descriptions of those inputs.

Remember, the DSP56367 offers 150 million instructions per second (MIPS) using an internal 150 MHz clock at 1.8 V and 100 million instructions per second (MIPS) using an internal 100 MHz clock at 1.3.3V.

Functional Grou	Number of Signals	Detailed Description	
Power (V _{CC})		20	Table 2-2
Ground (GND)		18	Table 2-3
Clock and PLL		3	Table 2-4
Address bus		18	Table 2-5
Data bus	Port A ¹	24	Table 2-6
Bus control	10	Table 2-7	
Interrupt and mode control		5	Table 2-8
HDI08	Port B ²	16	Table 2-9
SHI		5	Table 2-10
ESAI	Port C ³	12	Table 2-11
ESAI_1	Port E ⁴	6	Table 2-12
Digital audio transmitter (DAX)	Port D ⁵	2	Table 2-13
Timer		1	Table 2-14
JTAG/OnCE Port		4	Table 2-15

Table 2-1	DSP56367	Functional	Signal	Groupings
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¹ Port A is the external memory interface port, including the external address bus, data bus, and control signals.

² Port B signals are the GPIO port signals which are multiplexed with the HDI08 signals.

³ Port C signals are the GPIO port signals which are multiplexed with the ESAI signals.

⁴ Port E signals are the GPIO port signals which are multiplexed with the ESAI_1 signals.

⁵ Port D signals are the GPIO port signals which are multiplexed with the DAX signals.

DSP56367 Technical Data, Rev. 2.1

Signal Groupings

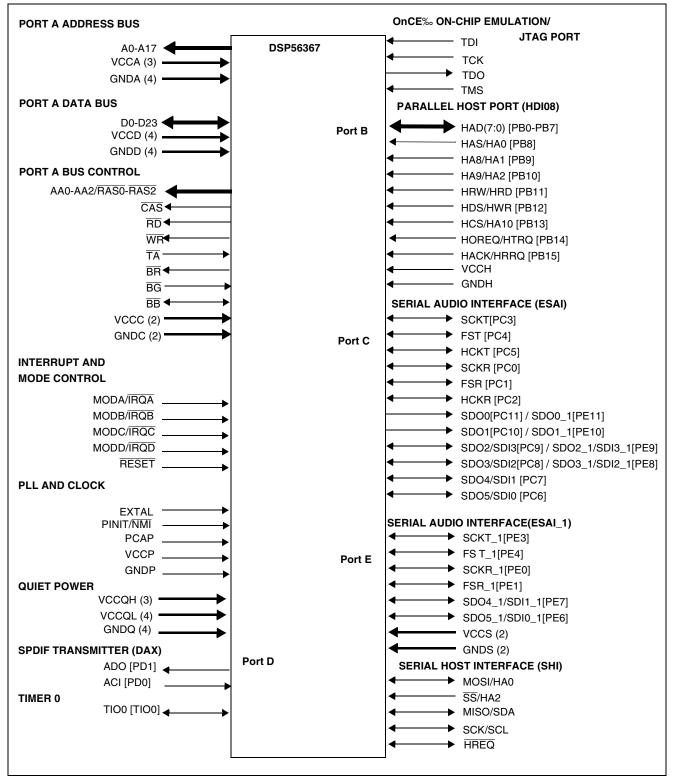


Figure 2-1 Signals Identified by Functional Group

2.2 Power

Table 2-2	Power	Inputs
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Power Name	Description
V _{CCP}	PLL Power — V_{CCP} is V_{CC} dedicated for PLL use. The voltage should be well-regulated and the input should be provided with an extremely low impedance path to the V_{CC} power rail. There is one V_{CCP} input.
V _{CCQL} (4)	Quiet Core (Low) Power — V_{CCQL} is an isolated power for the internal processing logic. This input must be tied externally to all other V_{CCQL} power pins and the V_{CCP} power pin only. Do not tie with other power pins. The user must provide adequate external decoupling capacitors. There are four V_{CCQL} inputs.
V _{CCQH} (3)	Quiet External (High) Power — V_{CCQH} is a quiet power source for I/O lines. This input must be tied externally to all other chip power inputs. The user must provide adequate decoupling capacitors. There are three V_{CCQH} inputs.
V _{CCA} (3)	Address Bus Power— V_{CCA} is an isolated power for sections of the address bus I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are three V_{CCA} inputs.
V _{CCD} (4)	Data Bus Power — V_{CCD} is an isolated power for sections of the data bus I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are four V_{CCD} inputs.
V _{CCC} (2)	Bus Control Power — V_{CCC} is an isolated power for the bus control I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are two V_{CCC} inputs.
V _{CCH}	Host Power — V_{CCH} is an isolated power for the HDI08 I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There is one V_{CCH} input.
V _{CCS} (2)	SHI, ESAI, ESAI_1, DAX and Timer Power —V _{CCS} is an isolated power for the SHI, ESAI, ESAI_1, DAX and Timer. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are two V _{CCS} inputs.

2.3 Ground

Table 2-3 Grounds

Ground Name	Description
GND _P	PLL Ground —GND _P is a ground dedicated for PLL use. The connection should be provided with an extremely low-impedance path to ground. V_{CCP} should be bypassed to GND _P by a 0.47 μ F capacitor located as close as possible to the chip package. There is one GND _P connection.
GND _Q (4)	Quiet Ground — GND_Q is an isolated ground for the internal processing logic. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are four GND_Q connections.
GND _A (4)	Address Bus Ground —GND _A is an isolated ground for sections of the address bus I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are four GND _A connections.
GND _D (4)	Data Bus Ground —GND _D is an isolated ground for sections of the data bus I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are four GND _D connections.

DSP56367 Technical Data, Rev. 2.1

Clock and PLL

Ground Name	Description				
GND _C (2)	Bus Control Ground — GND_C is an isolated ground for the bus control I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are two GND_C connections.				
GND _H	Host Ground —GND _h is an isolated ground for the HD08 I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There is one GND _H connection.				
GND _S (2)	SHI, ESAI, ESAI_1, DAX and Timer Ground —GND _S is an isolated ground for the SHI, ESAI, ESAI_1, DAX and Timer. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are two GND _S connections.				

Table 2-3 Grounds (continued)

2.4 Clock and PLL

Signal Name	Туре	State During Reset	Signal Description
EXTAL	Input	Input	External Clock Input —An external clock source must be connected to EXTAL in order to supply the clock to the internal clock generator and PLL.
PCAP	Input	Input	PLL Capacitor —PCAP is an input connecting an off-chip capacitor to the PLL filter. Connect one capacitor terminal to PCAP and the other terminal to V_{CCP} If the PLL is not used, PCAP may be tied to V_{CC} , GND, or left floating.
PINIT/NMI	Input	Input	PLL Initial/Nonmaskable Interrupt —During assertion of RESET, the value of PINIT/NMI is written into the PLL Enable (PEN) bit of the PLL control register, determining whether the PLL is enabled or disabled. After RESET de assertion and during normal instruction processing, the PINIT/NMI Schmitt-trigger input is a negative-edge-triggered nonmaskable interrupt (NMI) request internally synchronized to internal system clock.

Table 2-4 Clock and PLL Signals

2.5 External Memory Expansion Port (Port A)

When the DSP56367 enters a low-power standby mode (stop or wait), it releases bus mastership and tri-states the relevant port A signals: A0–A17, D0–D23, AA0/RAS0–AA2/RAS2, RD, WR, BB, CAS.

2.6 External Address Bus

Table 2-5	External	Address	Bus	Signals
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Signal Name	Туре	State During Reset	Signal Description
A0–A17	Output	Tri-Stated	Address Bus —When the DSP is the bus master, A0–A17 are active-high outputs that specify the address for external program and data memory accesses. Otherwise, the signals are tri-stated. To minimize power dissipation, A0–A17 do not change state when external memory spaces are not being accessed.

2.7 External Data Bus

Signal Name	Туре	State during Reset	Signal Description
D0-D23	Input/Output		Data Bus —When the DSP is the bus master, D0–D23 are active-high, bidirectional input/outputs that provide the bidirectional data bus for external program and data memory accesses. Otherwise, D0–D23 are tri-stated.

 Table 2-6
 External Data Bus Signals

2.8 External Bus Control

Signal Name	Туре	State During Reset	Signal Description
AA0-AA2/ RAS0-RAS2	Output	Tri-Stated	Address Attribute or Row Address Strobe—When defined as AA, these signals can be used as chip selects or additional address lines. When defined as RAS, these signals can be used as RAS for DRAM interface. These signals are tri-statable outputs with programmable polarity.
CAS	Output	Tri-Stated	Column Address Strobe — When the DSP is the bus master, CAS is an active-low output used by DRAM to strobe the column address. Otherwise, if the bus mastership enable (BME) bit in the DRAM control register is cleared, the signal is tri-stated.
RD	Output	Tri-Stated	Read Enable —When the DSP is the bus master, $\overline{\text{RD}}$ is an active-low output that is asserted to read external memory on the data bus (D0-D23). Otherwise, $\overline{\text{RD}}$ is tri-stated.
WR	Output	Tri-Stated	Write Enable —When the DSP is the bus master, \overline{WR} is an active-low output that is asserted to write external memory on the data bus (D0-D23). Otherwise, \overline{WR} is tri-stated.
TA	Input	Ignored Input	Transfer Acknowledge —If the DSP is the bus master and there is no external bus activity, or the DSP is not the bus master, the TA input is ignored. The TA input is a data transfer acknowledge (DTACK) function that can extend an external bus cycle indefinitely. Any number of wait states (1, 2 infinity) may be added to the wait states inserted by the BCR by keeping TA deasserted. In typical operation, TA is deasserted at the start of a bus cycle, is asserted to enable completion of the bus cycle, and is deasserted before the next bus cycle. The current bus cycle completes one clock period after TA is asserted synchronous to the internal system clock. The number of wait states is determined by the TA input or by the bus control register (BCR), whichever is longer. The BCR can be used to set the minimum number of wait states in external bus cycles. In order to use the TA functionality, the BCR must be programmed to at least one wait state. A zero wait state access cannot be extended by TA deassertion, otherwise improper operation may result. TA can operate synchronously or asynchronously, depending on the setting of the TAS bit in the operating mode register (OMR). TA functionality may not be used while performing DRAM type accesses, otherwise improper operation may result.

Table 2-7 External Bus Control Signals

Interrupt and Mode Control

Signal Name	Туре	State During Reset	Signal Description
BR	Output	Output (deasserted)	Bus Request —BR is an active-low output, never tri-stated. BR is asserted when the DSP requests bus mastership. BR is deasserted when the DSP no longer needs the bus. BR may be asserted or deasserted independent of whether the DSP56367 is a bus master or a bus slave. Bus "parking" allows BR to be deasserted even though the DSP56367 is the bus master. (See the description of bus "parking" in the BB signal description.) The bus request hold (BRH) bit in the BCR allows BR to be asserted under software control even though the DSP does not need the bus. BR is typically sent to an external bus arbitrator that controls the priority, parking, and tenure of each master on the same external bus. BR is only affected by DSP requests for the external bus, never for the internal bus. During hardware reset, BR is deasserted and the arbitration is reset to the bus slave state.
BG	Input	Ignored Input	Bus Grant — \overline{BG} is an active-low input. \overline{BG} is asserted by an external bus arbitration circuit when the DSP56367 becomes the next bus master. When \overline{BG} is asserted, the DSP56367 must wait until \overline{BB} is deasserted before taking bus mastership. When \overline{BG} is deasserted, bus mastership is typically given up at the end of the current bus cycle. This may occur in the middle of an instruction that requires more than one external bus cycle for execution. For proper \overline{BG} operation, the asynchronous bus arbitration enable bit (ABE) in the OMR register must be set.
BB	Input/ Output	Input	Bus Busy —BB is a bidirectional active-low input/output. BB indicates that the bus is active. Only after BB is deasserted can the pending bus master become the bus master (and then assert the signal again). The bus master may keep BB asserted after ceasing bus activity regardless of whether BR is asserted or deasserted. This is called "bus parking" and allows the current bus master to reuse the bus without rearbitration until another device requires the bus. The deassertion of BB is done by an "active pull-up" method (i.e., BB is driven high and then released and held high by an external pull-up resistor). For proper BB operation, the asynchronous bus arbitration enable bit (ABE) in the OMR register must be set. BB requires an external pull-up resistor.

Table 2-7	External Bus Control Signals (continued)
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2.9 Interrupt and Mode Control

The interrupt and mode control signals select the chip's operating mode as it comes out of hardware reset. After $\overline{\text{RESET}}$ is deasserted, these inputs are hardware interrupt request lines.

Interrupt and Mode Control

Table 2-8	Interrupt and	Mode Control
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Signal Name	Туре	State During Reset	Signal Description
MODA/IRQA	Input	Input	Mode Select A/External Interrupt Request A —MODA/IRQA is an active-low Schmitt-trigger input, internally synchronized to the DSP clock. MODA/IRQA selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input during normal instruction processing. MODA, MODB, MODC, and MODD select one of 16 initial chip operating modes, latched into the OMR when the RESET signal is deasserted. If the processor is in the stop standby state and the MODA/IRQA pin is pulled to GND, the processor will exit the stop state. <i>This input is 3.3V tolerant.</i>
MODB/IRQB	Input	Input	Mode Select B/External Interrupt Request B —MODB/IRQB is an active-low Schmitt-trigger input, internally synchronized to the DSP clock. MODB/IRQB selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input during normal instruction processing. MODA, MODB, MODC, and MODD select one of 16 initial chip operating modes, latched into OMR when the RESET signal is deasserted. This input is 3.3V tolerant.
MODC/IRQC	Input	Input	Mode Select C/External Interrupt Request C—MODC/IRQC is an active-low Schmitt-trigger input, internally synchronized to the DSP clock. MODC/IRQC selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input during normal instruction processing. MODA, MODB, MODC, and MODD select one of 16 initial chip operating modes, latched into OMR when the RESET signal is deasserted. This input is 3.3V tolerant.
MODD/IRQD	Input	Input	Mode Select D/External Interrupt Request D —MODD/IRQD is an active-low Schmitt-trigger input, internally synchronized to the DSP clock. MODD/IRQD selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input during normal instruction processing. MODA, MODB, MODC, and MODD select one of 16 initial chip operating modes, latched into OMR when the RESET signal is deasserted. This input is 3.3V tolerant.
RESET	Input	Input	Reset —RESET is an active-low, Schmitt-trigger input. When asserted, the chip is placed in the Reset state and the internal phase generator is reset. The Schmitt-trigger input allows a slowly rising input (such as a capacitor charging) to reset the chip reliably. When the RESET signal is deasserted, the initial chip operating mode is latched from the MODA, MODB, MODC, and MODD inputs. The RESET signal must be asserted during power up. A stable EXTAL signal must be supplied while RESET is being asserted. <i>This input is 3.3V tolerant.</i>

Parallel Host Interface (HDI08)

2.10 Parallel Host Interface (HDI08)

The HDI08 provides a fast, 8-bit, parallel data port that may be connected directly to the host bus. The HDI08 supports a variety of standard buses and can be directly connected to a number of industry standard microcomputers, microprocessors, DSPs, and DMA hardware.

Signal Name	Туре	State During Reset	Signal Description
H0H7	Input/ Output	GPIO Disconnected	Host Data —When HDI08 is programmed to interface a nonmultiplexed host bus and the HI function is selected, these signals are lines 0–7 of the bidirectional, tri-state data bus.
HAD0-HAD7	Input/ Output		Host Address/Data —When HDI08 is programmed to interface a multiplexed host bus and the HI function is selected, these signals are lines 0–7 of the address/data bidirectional, multiplexed, tri-state bus.
PB0-PB7	Input, Output, or Disconnected		Port B 0–7 —When the HDI08 is configured as GPIO, these signals are individually programmable as input, output, or internally disconnected. The default state after reset for these signals is GPIO disconnected. These inputs are 3.3V tolerant.
HAO	Input	GPIO Disconnected	Host Address Input 0 —When the HDI08 is programmed to interface a nonmultiplexed host bus and the HI function is selected, this signal is line 0 of the host address input bus.
HAS/HAS	Input		Host Address Strobe —When HDI08 is programmed to interface a multiplexed host bus and the HI function is selected, this signal is the host address strobe (HAS) Schmitt-trigger input. The polarity of the address strobe is programmable, but is configured active-low (HAS) following reset.
PB8	Input, Output, or Disconnected		Port B 8 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected. The default state after reset for this signal is GPIO disconnected. This input is 3.3V tolerant.
HA1	Input	GPIO Disconnected	Host Address Input 1—When the HDI08 is programmed to interface a nonmultiplexed host bus and the HI function is selected, this signal is line 1 of the host address (HA1) input bus.
HA8	Input		Host Address 8 —When HDI08 is programmed to interface a multiplexed host bus and the HI function is selected, this signal is line 8 of the host address (HA8) input bus.
PB9	Input, Output, or Disconnected		Port B 9 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected. The default state after reset for this signal is GPIO disconnected. This input is 3.3V tolerant.

Table 2-9 Host Interface

Parallel Host Interface (HDI08)

Signal Name	Туре	State During Reset	Signal Description
HA2	Input	GPIO Disconnected	Host Address Input 2—When the HDI08 is programmed to interface a non-multiplexed host bus and the HI function is selected, this signal is line 2 of the host address (HA2) input bus.
HA9	Input		Host Address 9 —When HDI08 is programmed to interface a multiplexed host bus and the HI function is selected, this signal is line 9 of the host address (HA9) input bus.
PB10	Input, Output, or Disconnected		Port B 10 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected.
			This input is 3.3V tolerant.
HRW	Input	GPIO Disconnected	Host Read/Write—When HDI08 is programmed to interface a single-data-strobe host bus and the HI function is selected, this signal is the Host Read/Write (HRW) input.
HRD/ HRD	Input		Host Read Data —When HDI08 is programmed to interface a double-data-strobe host bus and the HI function is selected, this signal is the host read data strobe (HRD) Schmitt-trigger input. The polarity of the data strobe is programmable, but is configured as active-low (HRD) after reset.
PB11	Input, Output, or Disconnected		Port B 11 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected.
			This input is 3.3V tolerant.
HDS/ HDS	Input	GPIO Disconnected	Host Data Strobe —When HDI08 is programmed to interface a single-data-strobe host bus and the HI function is selected, this signal is the host data strobe (HDS) Schmitt-trigger input. The polarity of the data strobe is programmable, but is configured as active-low (HDS) following reset.
HWR/ HWR	Input		Host Write Data —When HDI08 is programmed to interface a double-data-strobe host bus and the HI function is selected, this signal is the host write data strobe (HWR) Schmitt-trigger input. The polarity of the data strobe is programmable, but is configured as active-low (HWR) following reset.
PB12	Input, Output, or Disconnected		Port B 12 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected.
			This input is 3.3V tolerant.

Table 2-9	Host Interface	(continued)
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Parallel Host Interface (HDI08)

Signal Name	Туре	State During Reset	Signal Description
HCS	Input	GPIO Disconnected	Host Chip Select —When HDI08 is programmed to interface a nonmultiplexed host bus and the HI function is selected, this signal is the host chip select (HCS) input. The polarity of the chip select is programmable, but is configured active-low (HCS) after reset.
HA10	Input		Host Address 10 —When HDI08 is programmed to interface a multiplexed host bus and the HI function is selected, this signal is line 10 of the host address (HA10) input bus.
PB13	Input, Output, or Disconnected		Port B 13 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected.
			This input is 3.3V tolerant.
HOREQ/ HOREQ	Output	GPIO Disconnected	Host Request —When HDI08 is programmed to interface a single host request host bus and the HI function is selected, this signal is the host request (HOREQ) output. The polarity of the host request is programmable, but is configured as active-low (HOREQ) following reset. The host request may be programmed as a driven or open-drain output.
HTRQ/ HTRQ	Output		Transmit Host Request —When HDI08 is programmed to interface a double host request host bus and the HI function is selected, this signal is the transmit host request (HTRQ) output. The polarity of the host request is programmable, but is configured as active-low (HTRQ) following reset. The host request may be programmed as a driven or open-drain output.
PB14	Input, Output, or Disconnected		Port B 14 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected. This input is 3.3V tolerant.
HACK/ HACK	Input	GPIO Disconnected	Host Acknowledge —When HDI08 is programmed to interface a single host request host bus and the HI function is selected, this signal is the host acknowledge (HACK) Schmitt-trigger input. The polarity of the host acknowledge is programmable, but is configured as active-low (HACK) after reset.
HRRQ/ HRRQ	Output		Receive Host Request —When HDI08 is programmed to interface a double host request host bus and the HI function is selected, this signal is the receive host request (HRRQ) output. The polarity of the host request is programmable, but is configured as active-low (HRRQ) after reset. The host request may be programmed as a driven or open-drain output.
PB15	Input, Output, or Disconnected		Port B 15 —When the HDI08 is configured as GPIO, this signal is individually programmed as input, output, or internally disconnected.
			The default state after reset for this signal is GPIO disconnected. This input is 3.3V tolerant.

Table 2-9 Host Interface (continued)

2.11 Serial Host Interface

The SHI has five I/O signals that can be configured to allow the SHI to operate in either SPI or I^2C mode.

Signal Name	Signal Type	State During Reset	Signal Description
SCK	Input or Output	Tri-Stated	SPI Serial Clock —The SCK signal is an output when the SPI is configured as a master and a Schmitt-trigger input when the SPI is configured as a slave. When the SPI is configured as a master, the SCK signal is derived from the internal SHI clock generator. When the SPI is configured as a slave, the SCK signal is an input, and the clock signal from the external master synchronizes the data transfer. The SCK signal is ignored by the SPI if it is defined as a slave and the slave select (SS) signal is not asserted. In both the master and slave SPI devices, data is shifted on one edge of the SCK signal and is sampled on the opposite edge where data is stable. Edge polarity is determined by the SPI transfer protocol.
SCL	Input or Output		I²C Serial Clock —SCL carries the clock for I ² C bus transactions in the I ² C mode. SCL is a Schmitt-trigger input when configured as a slave and an open-drain output when configured as a master. SCL should be connected to V_{CC} through a pull-up resistor.
			This signal is tri-stated during hardware, software, and individual reset. Thus, there is no need for an external pull-up in this state.
			This input is 3.3V tolerant.
MISO	Input or Output	Tri-Stated	SPI Master-In-Slave-Out —When the SPI is configured as a master, MISO is the master data input line. The MISO signal is used in conjunction with the MOSI signal for transmitting and receiving serial data. This signal is a Schmitt-trigger input when configured for the SPI Master mode, an output when configured for the SPI Slave mode, and tri-stated if configured for the SPI Slave mode when \overline{SS} is deasserted. An external pull-up resistor is not required for SPI operation.
SDA	Input or Open-Drain Output		I^2C Data and Acknowledge—In I^2C mode, SDA is a Schmitt-trigger input when receiving and an open-drain output when transmitting. SDA should be connected to V_{CC} through a pull-up resistor. SDA carries the data for I^2C transactions. The data in SDA must be stable during the high period of SCL. The data in SDA is only allowed to change when SCL is low. When the bus is free, SDA is high. The SDA line is only allowed to change during the time SCL is high in the case of start and stop events. A high-to-low transition of the SDA line while SCL is high is a unique situation, and is defined as the start event. A low-to-high transition of SDA while SCL is high is a unique situation defined as the stop event.
			This signal is tri-stated during hardware, software, and individual reset. Thus, there is no need for an external pull-up in this state.
			This input is 3.3V tolerant.

Table 2-10 Serial Host Interface Signals

Serial Host Interface

Signal Name	Signal Type	State During Reset	Signal Description		
MOSI	Input or Output	Tri-Stated	SPI Master-Out-Slave-In —When the SPI is configured as a master, MOSI is the master data output line. The MOSI signal is used in conjunction with the MISO signal for transmitting and receiving serial data. MOSI is the slave data input line when the SPI is configured as a slave. This signal is a Schmitt-trigger input when configured for the SPI Slave mode.		
HA0	Input		I^2C Slave Address 0—This signal uses a Schmitt-trigger input when configured for the I^2C mode. When configured for I^2C slave mode, the HA0 signal is used to form the slave device address. HA0 is ignored when configured for the I^2C master mode. This signal is tri-stated during hardware, software, and individual reset. Thus, there is no need for an external pull-up in this state. This input is 3.3V tolerant.		
55	Input	Tri-Stated	SPI Slave Select —This signal is an active low Schmitt-trigger input when configured for the SPI mode. When configured for the SPI Slave mode, this signal is used to enable the SPI slave for transfer. When configured for the SPI master mode, this signal should be kept deasserted (pulled high). If it is asserted while configured as SPI master, a bus error condition is flagged. If SS is deasserted, the SHI ignores SCK clocks and keeps the MISO output signal in the high-impedance state.		
HA2	Input		I^2C Slave Address 2—This signal uses a Schmitt-trigger input when configured for the I^2C mode. When configured for the I^2C Slave mode, the HA2 signal is used to form the slave device address. HA2 is ignored in the I^2C master mode. This signal is tri-stated during hardware, software, and individual reset. Thus, there is no need for an external pull-up in this state. This input is 3.3V tolerant.		
HREQ	Input or Output	Tri-Stated	Host Request —This signal is an active low Schmitt-trigger input when configured for the master mode but an active low output when configured for the slave mode. When configured for the slave mode, \overline{HREQ} is asserted to indicate that the SHI is ready for the next data word transfer and deasserted at the first clock pulse of the new data word transfer. When configured for the master mode, \overline{HREQ} is an input. When asserted by the external slave device, it will trigger the start of the data word transfer by the master. After finishing the data word transfer, the master will await the next assertion of \overline{HREQ} to proceed to the next transfer. This signal is tri-stated during hardware, software, personal reset, or when the HREQ1–HREQ0 bits in the HCSR are cleared. There is no need for external pull-up in this state.		

Table 2-10 Serial Host Interface Signals (continued)

Enhanced Serial Audio Interface

2.12 Enhanced Serial Audio Interface

Table 2-11 Enhanced Serial Audio Interface Signals

Signal Name	Signal Type	State during Reset	Signal Description
HCKR	Input or Output	GPIO Disconnected	High Frequency Clock for Receiver —When programmed as an input, this signal provides a high frequency clock source for the ESAI receiver as an alternate to the DSP core clock. When programmed as an output, this signal can serve as a high-frequency sample clock (e.g., for external digital to analog converters [DACs]) or as an additional system clock.
PC2	Input, Output, or Disconnected		Port C 2 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected. The default state after reset is GPIO disconnected. This input is 3.3V tolerant.
НСКТ	Input or Output	GPIO Disconnected	High Frequency Clock for Transmitter —When programmed as an input, this signal provides a high frequency clock source for the ESAI transmitter as an alternate to the DSP core clock. When programmed as an output, this signal can serve as a high frequency sample clock (e.g., for external DACs) or as an additional system clock.
PC5	Input, Output, or Disconnected		Port C 5 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.
FSR	Input or Output	GPIO Disconnected	Frame Sync for Receiver —This is the receiver frame sync input/output signal. In the asynchronous mode (SYN=0), the FSR pin operates as the frame sync input or output used by all the enabled receivers. In the synchronous mode (SYN=1), it operates as either the serial flag 1 pin (TEBE=0), or as the transmitter external buffer enable control (TEBE=1, RFSD=1).
			When this pin is configured as serial flag pin, its direction is determined by the RFSD bit in the RCCR register. When configured as the output flag OF1, this pin will reflect the value of the OF1 bit in the SAICR register, and the data in the OF1 bit will show up at the pin synchronized to the frame sync in normal mode or the slot in network mode. When configured as the input flag IF1, the data value at the pin will be stored in the IF1 bit in the SAISR register, synchronized by the frame sync in normal mode or the slot in network mode.
PC1	Input, Output, or Disconnected		Port C 1 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.

Enhanced Serial Audio Interface

Table 2-11	Enhanced Serial Audio Interface Signals (continued)
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Signal Name	Signal Type	State during Reset	Signal Description
FST	Input or Output	GPIO Disconnected	Frame Sync for Transmitter —This is the transmitter frame sync input/output signal. For synchronous mode, this signal is the frame sync for both transmitters and receivers. For asynchronous mode, FST is the frame sync for the transmitters only. The direction is determined by the transmitter frame sync direction (TFSD) bit in the ESAI transmit clock control register (TCCR).
PC4	Input, Output, or Disconnected		Port C 4 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.
SCKR	Input or Output	GPIO Disconnected	Receiver Serial Clock —SCKR provides the receiver serial bit clock for the ESAI. The SCKR operates as a clock input or output used by all the enabled receivers in the asynchronous mode (SYN=0), or as serial flag 0 pin in the synchronous mode (SYN=1).
			When this pin is configured as serial flag pin, its direction is determined by the RCKD bit in the RCCR register. When configured as the output flag OF0, this pin will reflect the value of the OF0 bit in the SAICR register, and the data in the OF0 bit will show up at the pin synchronized to the frame sync in normal mode or the slot in network mode. When configured as the input flag IF0, the data value at the pin will be stored in the IF0 bit in the SAISR register, synchronized by the frame sync in normal mode or the slot in retwork mode.
PC0	Input, Output, or Disconnected		Port C 0 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.
SCKT	Input or output	GPIO Disconnected	Transmitter Serial Clock —This signal provides the serial bit rate clock for the ESAI. SCKT is a clock input or output used by all enabled transmitters and receivers in synchronous mode, or by all enabled transmitters in asynchronous mode.
PC3	Input, Output, or Disconnected		Port C 3 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.
SDO5	Output	GPIO Disconnected	Serial Data Output 5 —When programmed as a transmitter, SDO5 is used to transmit data from the TX5 serial transmit shift register.
SDI0	Input		Serial Data Input 0 —When programmed as a receiver, SDI0 is used to receive serial data into the RX0 serial receive shift register.
PC6	Input, Output, or Disconnected		Port C 6 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.

Table 2-11	Enhanced Serial Audio Interface Signals (continued)	ļ
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Signal Name	Signal Type	State during Reset	Signal Description
SDO4	Output	GPIO Disconnected	Serial Data Output 4 —When programmed as a transmitter, SDO4 is used to transmit data from the TX4 serial transmit shift register.
SDI1	Input		Serial Data Input 1 —When programmed as a receiver, SDI1 is used to receive serial data into the RX1 serial receive shift register.
PC7	Input, Output, or Disconnected		Port C 7 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.
SDO3/ SDO3_1	Output	GPIO Disconnected	Serial Data Output 3 —When programmed as a transmitter, SDO3 is used to transmit data from the TX3 serial transmit shift register.
0.510/			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Output 3.
SDI2/ SDI2_1	Input		Serial Data Input 2 —When programmed as a receiver, SDI2 is used to receive serial data into the RX2 serial receive shift register.
			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Input 2.
PC8/PE8	Input, Output, or Disconnected		Port C 8 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			When enabled for ESAI_1 GPIO, this is the Port E 8 signal.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.
SDO2/ SDO2_1	Output	GPIO Disconnected	Serial Data Output 2 —When programmed as a transmitter, SDO2 is used to transmit data from the TX2 serial transmit shift register.
			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Output 2.
SDI3/ SDI3_1	Input		Serial Data Input 3 —When programmed as a receiver, SDI3 is used to receive serial data into the RX3 serial receive shift register.
			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Input 3.
PC9/PE9	Input, Output, or Disconnected		Port C 9 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			When enabled for ESAI_1 GPIO, this is the Port E 9 signal.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.
SDO1/ SDO1_1	Output	GPIO Disconnected	Serial Data Output 1 —SDO1 is used to transmit data from the TX1 serial transmit shift register.
			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Output 1.
PC10/ PE10	Input, Output, or disconnected		Port C 10 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			When enabled for ESAI_1 GPIO, this is the Port E 10 signal.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.

Enhanced Serial Audio Interface_1

Signal Name	Signal Type	State during Reset	Signal Description
SDO0/ SDO0_1	Output	GPIO Disconnected	Serial Data Output 0—SDO0 is used to transmit data from the TX0 serial transmit shift register.
			When enabled for ESAI_1 operation, this is the ESAI_1 Serial Data Output 0.
PC11/ PE11	Input, Output, or Disconnected		Port C 11 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			When enabled for ESAI_1 GPIO, this is the Port E 11 signal.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.

2.13 Enhanced Serial Audio Interface_1

Signal Name	Signal Type	State during Reset	Signal Description
FSR_1	Input or Output	GPIO Disconnected	Frame Sync for Receiver_1 —This is the receiver frame sync input/output signal. In the asynchronous mode (SYN=0), the FSR pin operates as the frame sync input or output used by all the enabled receivers. In the synchronous mode (SYN=1), it operates as either the serial flag 1 pin (TEBE=0), or as the transmitter external buffer enable control (TEBE=1, RFSD=1).
PE1	Input, Output, or Disconnected		When this pin is configured as serial flag pin, its direction is determined by the RFSD bit in the RCCR register. When configured as the output flag OF1, this pin will reflect the value of the OF1 bit in the SAICR register, and the data in the OF1 bit will show up at the pin synchronized to the frame sync in normal mode or the slot in network mode. When configured as the input flag IF1, the data value at the pin will be stored in the IF1 bit in the SAISR register, synchronized by the frame sync in normal mode or the slot in network mode. Port E 1 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected. The default state after reset is GPIO disconnected.
FST_1	Input or Output	GPIO Disconnected	Frame Sync for Transmitter_1 —This is the transmitter frame sync input/output signal. For synchronous mode, this signal is the frame sync for both transmitters and receivers. For asynchronous mode, FST is the frame sync for the transmitters only. The direction is determined by the transmitter frame sync direction (TFSD) bit in the ESAI transmit clock control register (TCCR).
PE4	Input, Output, or Disconnected		Port E 4 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected.
			This input cannot tolerate 3.3V.

Table 2-12 Enhanced Serial Audio Interface_1 Signals

Signal Name	Signal Type	State during Reset	Signal Description
SCKR_1	Input or Output	GPIO Disconnected	Receiver Serial Clock_1 —SCKR provides the receiver serial bit clock for the ESAI. The SCKR operates as a clock input or output used by all the enabled receivers in the asynchronous mode (SYN=0), or as serial flag 0 pin in the synchronous mode (SYN=1).
PE0	Input, Output, or Disconnected		When this pin is configured as serial flag pin, its direction is determined by the RCKD bit in the RCCR register. When configured as the output flag OF0, this pin will reflect the value of the OF0 bit in the SAICR register, and the data in the OF0 bit will show up at the pin synchronized to the frame sync in normal mode or the slot in network mode. When configured as the input flag IF0, the data value at the pin will be stored in the IF0 bit in the SAISR register, synchronized by the frame sync in normal mode or the slot in network mode. Port E 0 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			This input cannot tolerate 3.3V.
SCKT_1	Input or Output	GPIO Disconnected	Transmitter Serial Clock_1 —This signal provides the serial bit rate clock for the ESAI. SCKT is a clock input or output used by all enabled transmitters and receivers in synchronous mode, or by all enabled transmitters in asynchronous mode.
PE3	Input, Output, or Disconnected		Port E 3 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected. The default state after reset is GPIO disconnected.
			This input cannot tolerate 3.3V.
SDO5_1	Output	GPIO Disconnected	Serial Data Output 5_1—When programmed as a transmitter, SDO5 is used to transmit data from the TX5 serial transmit shift register.
SDI0_1	Input		Serial Data Input 0_1—When programmed as a receiver, SDI0 is used to receive serial data into the RX0 serial receive shift register.
PE6	Input, Output, or Disconnected		Port E 6 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input cannot tolerate 3.3V.
SDO4_1	Output	GPIO Disconnected	Serial Data Output 4_1—When programmed as a transmitter, SDO4 is used to transmit data from the TX4 serial transmit shift register.
SDI1_1	Input		Serial Data Input 1_1—When programmed as a receiver, SDI1 is used to receive serial data into the RX1 serial receive shift register.
PE7	Input, Output, or Disconnected		Port E 7 —When the ESAI is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected. This input is 3.3V tolerant.

2.14 SPDIF Transmitter Digital Audio Interface

Table 2-13 Digital Audio Interface (DAX) Signals

Signal Name	Туре	State During Reset	Signal Description
ACI	Input	GPIO Disconnected	Audio Clock Input —This is the DAX clock input. When programmed to use an external clock, this input supplies the DAX clock. The external clock frequency must be 256, 384, or 512 times the audio sampling frequency $(256 \times Fs, 384 \times Fs \text{ or } 512 \times Fs, \text{ respectively}).$
PD0	Input, Output, or Disconnected		Port D 0 —When the DAX is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.
ADO	Output	GPIO Disconnected	Digital Audio Data Output —This signal is an audio and non-audio output in the form of AES/EBU, CP340 and IEC958 data in a biphase mark format.
PD1	Input, Output, or Disconnected		Port D 1 —When the DAX is configured as GPIO, this signal is individually programmable as input, output, or internally disconnected.
			The default state after reset is GPIO disconnected.
			This input is 3.3V tolerant.

2.15 Timer

Table 2-14 Timer Signal

Signal Name	Туре	State during Reset	Signal Description
TIOO	Input or Output	Input	Timer 0 Schmitt-Trigger Input/Output —When timer 0 functions as an external event counter or in measurement mode, TIO0 is used as input. When timer 0 functions in watchdog, timer, or pulse modulation mode, TIO0 is used as output.
			The default mode after reset is GPIO input. This can be changed to output or configured as a timer input/output through the timer 0 control/status register (TCSR0). If TIO0 is not being used, it is recommended to either define it as GPIO output immediately at the beginning of operation or leave it defined as GPIO input but connected to Vcc through a pull-up resistor in order to ensure a stable logic level at this input. This input is 3.3 V tolerant.

2.16 JTAG/OnCE Interface

Signal Name	Signal Type	State during Reset	Signal Description
ТСК	Input	Input	Test Clock —TCK is a test clock input signal used to synchronize the JTAG test logic. It has an internal pull-up resistor. This input is 3.3V tolerant.
TDI	Input	Input	Test Data Input —TDI is a test data serial input signal used for test instructions and data. TDI is sampled on the rising edge of TCK and has an internal pull-up resistor. This input is 3.3V tolerant.
TDO	Output	Tri-Stated	Test Data Output —TDO is a test data serial output signal used for test instructions and data. TDO is tri-statable and is actively driven in the shift-IR and shift-DR controller states. TDO changes on the falling edge of TCK.
TMS	Input	Input	Test Mode Select —TMS is an input signal used to sequence the test controller's state machine. TMS is sampled on the rising edge of TCK and has an internal pull-up resistor. This input is 3.3V tolerant.

Table 2-15 JTAG/OnCE Interface

JTAG/OnCE Interface

NOTES

3 Specifications

3.1 Introduction

The DSP56367 is a high density CMOS device with Transistor-Transistor Logic (TTL) compatible inputs and outputs.

NOTE

This document contains information on a new product. Specifications and information herein are subject to change without notice.

Finalized specifications may be published after further characterization and device qualifications are completed.

3.2 Maximum Ratings

CAUTION

This device contains circuitry protecting against damage due to high static voltage or electrical fields. However, normal precautions should be taken to avoid exceeding maximum voltage ratings. Reliability of operation is enhanced if unused inputs are pulled to an appropriate logic voltage level (for example, either GND or V_{CC}). The suggested value for a pull-up or pull-down resistor is 10 k Ω

NOTE

In the calculation of timing requirements, adding a maximum value of one specification to a minimum value of another specification does not yield a reasonable sum. A maximum specification is calculated using a worst case variation of process parameter values in one direction. The minimum specification is calculated using the worst case for the same parameters in the opposite direction. Therefore, a "maximum" value for a specification will never occur in the same device that has a "minimum" value for another specification; adding a maximum to a minimum represents a condition that can never exist.

Rating ¹	Symbol	Value ^{1, 2}	Unit
Supply Voltage	V _{CCQL,} V _{CCP}	-0.3 to + 2.0	V
	V _{CCQH} , V _{CCA} , V _{CCD} , V _{CCC} , V _{CCH} , V _{CCS} ,	-0.3 to + 4.0	V
All "3.3V tolerant" input voltages	V _{IN}	$GND - 0.3$ to $V_{CC} + 0.7$	V
Current drain per pin excluding $V_{\mbox{CC}}$ and GND	I	10	mA
Operating temperature range ³	TJ	-40 to + 95	°C
Storage temperature	T _{STG}	-55 to +125	°C

¹ GND = 0 V, VCCP, VCCQL = $1.8 \text{ V} \pm 5\%$, TJ = $-40 \times \text{C}$ to $+95 \times \text{C}$, CL = 50 pFAll other VCC = $3.3 \text{ V} \pm 5\%$, TJ = $-40 \times \text{C}$ to $+95 \times \text{C}$, CL = 50 pF

² Absolute maximum ratings are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond the maximum rating may affect device reliability or cause permanent damage to the device.

³ Temperatures below -0°C are qualified for consumer applications.

3.3 Thermal Characteristics

Table 3-2 Thermal Characteristics

Characteristic	Symbol	TQFP Value	Unit
Natural Convection, Junction-to-ambient thermal resistance ^{1,2}	$R_{\theta JA}$ or θ_{JA}	45.0	°C/W
Junction-to-case thermal resistance ³	$R_{\theta JC}$ or θ_{JC}	10.0	°C/W
Natural Convection, Thermal characterization parameter ⁴	Ψ_{JT}	3.0	°C/W

¹ Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

² Per SEMI G38-87 and JEDEC JESD51-2 with the single layer board horizontal.

- ³ Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- ⁴ Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

DC Electrical Characteristics

DC Electrical Characteristics 3.4

Characteristics	Symbol	Min	Тур	Мах	Unit
Supply voltages	V _{CC}	1.71	1.8	1.89	V
• Core (V _{CCQL})					
• PLL(V _{CCP})					
Supply voltages	V _{CC}	3.14	3.3	3.46	V
• V _{CCQH}					
• V _{CCA}					
• V _{CCD}					
• V _{CCC}					
• V _{CCH}					
• V _{CCS}					
Input high voltage					V
• D(0:23), BG, BB, TA, ESAI_1 (except SDO4_1)	V _{IH}	2.0	_	V _{CCQH}	
 MOD²/IRQ², RESET, PINIT/NMI and all JTAG/ESAI_1/Timer/HDI08/DAX/_(only SDO4_1)/SHI_(SPI mode) 	V _{IHP}	2.0	_	V _{CCQH} + 03 max for both V _{IHP}	
• SHI _(I2C mode)	V _{IHP}	1.5	_	V _{CCQH} + 03 max for both V _{IHP}	
• EXTAL	V_{IHX}	$0.8 \times V_{\text{CCQH}}$	_	$0.8 imes V_{CCQH}$	
Input low voltage					V
• D(0:23), BG, BB, TA, ESAI_1 _(except SDO4_1)	V _{IL}	-0.3	—	0.8	
 MOD²/IRQ², RESET, PINIT/NMI and all JTAG/ESAI/Timer/HDI08/DAX/ESAI_1_(only SDO4_1)/SHI_(SPI mode) 	V_{ILP}	-0.3	—	0.8	
• SHI _(I2C mode)	V _{ILP}	-0.3	_	$0.3 \times V_{CC}$	
• EXTAL	V_{ILX}	-0.3	—	$0.2 \times V_{CCQH}$	
Input leakage current	I _{IN}	-10	_	10	μA
High impedance (off-state) input current (@ 2.4 V / 0.4 V)	I _{TSI}	-10	_	10	μA
Output high voltage ³	V _{OH}	2.4	_	_	V
Output low voltage ³	V _{OL}	—	_	0.4	V
Internal supply current ⁴ at internal clock of 150MHz					mA
In Normal mode	I _{CCI}	—	58.0	115	
In Wait mode	ICCW	_	7.3	20	
 In Stop mode⁵ 	I _{CCS}		2.0	4	
PLL supply current		—	1	2.5	mA
Input capacitance ⁶	C _{IN}	_	_	10	pF

Table 3-3 DC I	Electrical	Characteristics ¹
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¹ $V_{CCQL} = 1.8 V \pm 5\%$, $T_J = -40^{\circ}C$ to $+95^{\circ}C$, $C_L = 50 \text{ pF}$ All other $V_{CC} = 3.3 V \pm 5\%$, $T^J = -40^{\circ}C$ to $+95^{\circ}C$, $C_L = 50 \text{ pF}$ ² Refers to MODA/IRQA, MODB/IRQB, MODC/IRQC, and MODD/IRQD pins.

DSP56367 Technical Data, Rev. 2.1

AC Electrical Characteristics

³ This characteristic does not apply to PCAP.

- ⁴ The Appendix A, "Power Consumption Benchmark" section provides a formula to compute the estimated current requirements in Normal mode. In order to obtain these results, all inputs must be terminated (i.e., not allowed to float). Measurements are based on synthetic intensive DSP benchmarks. The power consumption numbers in this specification are 90% of the measured results of this benchmark. This reflects typical DSP applications. Typical internal supply current is measured with $V_{CCQL} = 1.8V$, $V_{CC(other)} = 3.3V$ at $T_J = 25^{\circ}C$. Maximum internal supply current is measured with $V_{CCQL} = 1.89V$, $V_{CC(other)} = 3.46V$ at $T_J = 95^{\circ}C$.
- ⁵ In order to obtain these results, all inputs, which are not disconnected at Stop mode, must be terminated (i.e., not allowed to float).
- ⁶ Periodically sampled and not 100% tested

Internal Clocks

3.5 AC Electrical Characteristics

The timing waveforms shown in the AC electrical characteristics section are tested with a V_{IL} maximum of 0.4 V and a V_{IH} minimum of 2.4 V for all pins except EXTAL. AC timing specifications, which are referenced to a device input signal, are measured in production with respect to the 50% point of the respective input signal's transition. DSP56367 output levels are measured with the production test machine V_{OL} and V_{OH} reference levels set at 0.4 V and 2.4 V, respectively.

NOTE

Although the minimum value for the frequency of EXTAL is 0 MHz, the device AC test conditions are 15 MHz and rated speed.

Characteristics	Symbol	Expression ^{1, 2}			
Characteristics	Symbol	Min	Тур	Max	
Internal operation frequency with PLL enabled	f	—	(Ef \times MF)/(PDF \times DF)	—	
Internal operation frequency with PLL disabled	f	—	Ef/2	—	
Internal clock high period	т _н				
With PLL disabled		—	ET _C	—	
• With PLL enabled and MF ≤ 4		$0.49 \times ET_C \times PDF \times DF/MF$	—	0.51×ET _C ×PDF× DF/MF	
 With PLL enabled and MF > 4 		$0.47 \times ET_C \times PDF \times DF/MF$	—	0.53×ET _C ×PDF× DF/MF	
Internal clock low period	TL				
With PLL disabled		—	ET _C	—	
• With PLL enabled and MF \leq 4		0.49×ET _C ×PDF× DF/MF	_	0.51×ET _C ×PDF× DF/MF	
 With PLL enabled and MF > 4 		0.47×ET _C ×PDF× DF/MF	_	0.53×ET _C ×PDF× DF/MF	
Internal clock cycle time with PLL enabled	т _с	—	$\text{ET}_{\text{C}} \times \text{PDF} \times \text{DF/MF}$	_	

Table 3-4 Internal Clocks

3.6

External Clock Operation

Table 3-4	Internal	Clocks	(continued)
			(•••••)

Characteristics	Symbol	Expression ^{1, 2}		
Characteristics	Symbol	Min	Тур	Мах
Internal clock cycle time with PLL disabled	т _с	_	$2 \times \text{ET}_{\text{C}}$	—
Instruction cycle time	I _{CYC}	_	Τ _C	—

¹ DF = Division Factor Ef = External frequency

ET_C = External clock cycle

MF = Multiplication Factor

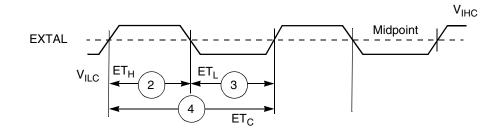
PDF = Predivision Factor

 T_C = internal clock cycle

 2 $\,$ Refer to the DSP56300 Family Manual for a detailed discussion of the PLL.

3.7 External Clock Operation

The DSP56367 system clock is an externally supplied square wave voltage source connected to EXTAL(Figure 3-1).



Note: The midpoint is 0.5 ($V_{IHC} + V_{ILC}$).

Figure 3-1 External Clock Timing

Table 3-5 Clock Operation

No.	Characteristics	Symbol	Min	Max
1	Frequency of EXTAL (EXTAL Pin Frequency) The rise and fall time of this external clock should be 2 ns maximum.	Ef	2.0 ns	150.0
2	EXTAL input high ^{1, 2} With PLL disabled (46.7%–53.3% duty cycle³) With PLL enabled (42.5%–57.5% duty cycle³) 	ET _H	3.11 ns 2.83 ns	∞ 157.0 μs
3	EXTAL input low ^{1, 2} With PLL disabled (46.7%–53.3% duty cycle³) With PLL enabled (42.5%–57.5% duty cycle³) 	ETL	3.11 ns 2.83 ns	∞ 157.0 μs

DSP56367 Technical Data, Rev. 2.1

Phase Lock Loop (PLL) Characteristics

No.	Characteristics	Symbol	Min	Max
4	EXTAL cycle time ²	ET _C		
	With PLL disabled		6.7 ns	~
	With PLL enabled		6.7 ns	273.1 μs
7	Instruction cycle time = $I_{CYC} = T_C^4$	I _{CYC}		
	With PLL disabled		13.33 ns	~
	With PLL enabled		6.67 ns	8.53 μs

 Table 3-5
 Clock Operation (continued)

¹ Measured at 50% of the input transition.

 $^2\,$ The maximum value for PLL enabled is given for minimum V_{CO} and maximum MF.

³ The indicated duty cycle is for the specified maximum frequency for which a part is rated. The minimum clock high or low time required for correct operation, however, remains the same at lower operating frequencies; therefore, when a lower clock frequency is used, the signal symmetry may vary from the specified duty cycle as long as the minimum high time and low time requirements are met.

 4 The maximum value for PLL enabled is given for minimum V_{CO} and maximum DF.

3.8 Phase Lock Loop (PLL) Characteristics

Table 3-6 PLL Characteristics

Characteristics	Min	Мах	Unit
V_{CO} frequency when PLL enabled (MF \times E_f \times 2/PDF)	30	300	MHz
PLL external capacitor (PCAP pin to V_{CCP}) (C_{PCAP} ¹⁾			pF
• @ MF ≤ 4	(MF × 580) – 100	(MF × 780) – 140	
• @ MF > 4	MF × 830	MF × 1470	

¹ C_{PCAP} is the value of the PLL capacitor (connected between the PCAP pin and V_{CCP}). The recommended value in pF for C_{PCAP} can be computed from one of the following equations:

(MF x 680)-120, for MF \leq 4, or MF x 1100, for MF > 4.

3.9 Reset, Stop, Mode Select, and Interrupt Timing

Table 3-7	Reset, Stop,	Mode Select,	and Interru	pt Timing ¹

No.	Characteristics	Expression	Min	Max	Unit
8	Delay from RESET assertion to all pins at reset value ²	_	_	26.0	ns
9	Required RESET duration ³				
	Power on, external clock generator, PLL disabled	$50 \times \text{ET}_{\text{C}}$	333.4	—	ns
	Power on, external clock generator, PLL enabled	$1000 \times \text{ET}_{\text{C}}$	6.7	—	μs
	Power on, Internal oscillator	$75000 imes \text{ET}_{\text{C}}$	500	—	μs
	During STOP, XTAL disabled	$75000 imes \text{ET}_{\text{C}}$	500	—	μs
	During STOP, XTAL enabled	$2.5 imes T_C$	16.7	—	ns
	During normal operation	$2.5 imes T_{C}$	16.7	—	ns
10	Delay from asynchronous RESET deassertion to first external address output (internal reset deassertion) ⁴				ns
	• Minimum	3.25 × TC + 2.0	23.7	—	
	• Maximum	20.25 × TC + 10	—	145.0	
11	Syn reset setup time from RESET				ns
	• Maximum	Т _С	—	6.7	
12	Syn reset deassert delay time				ns
	• Minimum	$3.25 \times T_{C} + 1.0$	22.7	—	
	• Maximum	$20.25 \times T_{C} + 5.0$	—	140.0	
13	Mode select setup time		30.0	_	ns
14	Mode select hold time		0.0	_	ns
15	Minimum edge-triggered interrupt request assertion width		4.4	_	ns
16	Minimum edge-triggered interrupt request deassertion width		4.4	_	ns
17	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to external memory access address out valid				ns
	Caused by first interrupt instruction fetch	$4.25 imes T_{C} + 2.0$	30.3	—	
	Caused by first interrupt instruction execution	$7.25 \times T_{C} + 2.0$	50.3	_	
18	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to general-purpose transfer output valid caused by first interrupt instruction execution	10 × T _C + 5.0	71.7	_	ns
19	Delay from address output valid caused by first interrupt instruction execute to interrupt request deassertion for level sensitive fast interrupts ^{5, 6, 7}	(WS + 3.75) × T _C – 10.94	_	Note 8	ns
20	Delay from $\overline{\text{RD}}$ assertion to interrupt request deassertion for level sensitive fast interrupts ^{5, 6, 7}	$(WS + 3.25) \times T_C - 10.94$	_	Note 8	ns

DSP56367 Technical Data, Rev. 2.1

Reset, Stop, Mode Select, and Interrupt Timing

No.	Characteristics	Expression	Min	Max	Unit
21	Delay from $\overline{\text{WR}}$ assertion to interrupt request deassertion for level sensitive fast interrupts ^{5, 6, 7}				ns
	DRAM for all WS	$(WS + 3.5) \times T_C - 10.94$	_	Note 8	
	• SRAM WS = 1	N/A	_	Note 8	
	• SRAM WS = 2, 3	$1.75 imes T_{C} - 4.0$	—	Note 8	
	• SRAM WS ≥ 4	$2.75 imes T_{C} - 4.0$	—	Note 8	
22	Synchronous int setup time from IRQs NMI assertion to the CLKOUT trans.	$0.6 imes T_{C} - 0.1$	3.9	—	ns
23	Synch. int delay time from the CLKOUT trans2 to the first external address out valid caused by first inst fetch				ns
	• Minimum	$9.25 imes T_{C} + 1.0$	62.7	—	
	• Maximum	$24.75 \times T_{C} + 5.0$	—	170.0	
24	Duration for IRQA assertion to recover from Stop state	$0.6 imes T_{C} - 0.1$	3.9	_	ns
25	Delay from IRQA assertion to fetch of first instruction (when exiting Stop) ^{2, 8}				
	 PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is enabled (OMR Bit 6 = 0) 	$\begin{array}{c} PLC \times ET_{C} \times PDF + (128 \ K \\ - \ PLC/2) \times T_{C} \end{array}$	—	_	ms
	 PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is not enabled (OMR Bit 6 = 1) 	$\begin{array}{c} PLC \times ET_{C} \times PDF + (23.75 \\ +/\text{-} 0.5) \times T_{C} \end{array}$	—	_	ms
	 PLL is active during Stop (PCTL Bit 17 = 1) (Implies No Stop Delay) 	$(8.25\pm0.5)\times T_{C}$	51.7	58.3	ns
26	Duration of level sensitive IRQA assertion to ensure interrupt service (when exiting Stop) ^{2, 8}				
	 PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is enabled (OMR Bit 6 = 0) 	$\begin{array}{l} PLC \times ET_{C} \times PDF + (128 \ K \\ - \ PLC/2) \times T_{C} \end{array}$	—	—	ms
	 PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is not enabled (OMR Bit 6 = 1) 	$\begin{array}{c} PLC \times ET_C \times PDF + (20.5 \\ +/\text{-} 0.5) \times T_C \end{array}$	—	—	ms
	 PLL is active during Stop (PCTL Bit 17 = 1) (implies no Stop delay) 	$5.5 imes T_{C}$	36.7	_	ns
27	Interrupt Requests Rate				ns
	HDI08, ESAI, ESAI_1, SHI, DAX, Timer	12T _C	—	80.0	
	• DMA	8T _C	—	53.0	
	IRQ, NMI (edge trigger)	8T _C	—	53.0	
	• IRQ (level trigger)	12T _C	—	80.0	

Table 3-7	Reset. Stop. Mode	Select. and Interrupt	Timing ¹ (continued)
		ocicet, and interrupt	

No.	Characteristics	Expression	Min	Max	Unit
28	DMA Requests Rate				ns
	Data read from HDI08, ESAI, ESAI_1, SHI, DAX	6Т _С	—	40.0	
	Data write to HDI08, ESAI, ESAI_1, SHI, DAX	7T _C	—	46.7	
	• Timer	2T _C		13.3	
	• IRQ, NMI (edge trigger)	ЗТ _С	—	20.0	
29	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to external memory (DMA source) access address out valid	$4.25 \times T_{C} + 2.0$	30.3	_	ns

Table 3-7 Reset, Stop, Mode Select, and Interrupt Timing¹ (continued)

¹ $V_{CCQH} = 3.3 \text{ V} \pm 5\%; V_{CC} = 1.8 \text{V} \pm 5\%; T_{J} = -40^{\circ}\text{C} \text{ to} + 95^{\circ}\text{C}, C_{L} = 50 \text{ pF}$

² Periodically sampled and not 100% tested.

⁴ If PLL does not lose lock.

⁵ When using fast interrupts and IRQA, IRQB, IRQC, and IRQD are defined as level-sensitive, timings 19 through 21 apply to prevent multiple interrupt service. To avoid these timing restrictions, the deasserted Edge-triggered mode is recommended when using fast interrupts. Long interrupts are recommended when using Level-sensitive mode.

- 6 WS = number of wait states (measured in clock cycles, number of T_C).
- ⁷ Use expression to compute maximum value.
- ⁸ This timing depends on several settings:

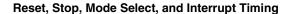
For PLL disable, using external clock (PCTL Bit 16 = 1), no stabilization delay is required and recovery time will be defined by the PCTL Bit 17 and OMR Bit 6 settings.

For PLL enable, if PCTL Bit 17 is 0, the PLL is shutdown during Stop. Recovering from Stop requires the PLL to get locked. The PLL lock procedure duration, PLL Lock Cycles (PLC), may be in the range of 0 to 1000 cycles. This procedure occurs in parallel with the stop delay counter, and stop recovery will end when the last of these two events occurs: the stop delay counter completes count or PLL lock procedure completion.

PLC value for PLL disable is 0.

The maximum value for ET_C is 4096 (maximum MF) divided by the desired internal frequency (i.e., for 150 MHz it is 4096/150 MHz = 27.3 µs). During the stabilization period, T_C , T_H , and T_L will not be constant, and their width may vary, so timing may vary as well.

³ RESET duration is measured during the time in which RESET is asserted, V_{CC} is valid, and the EXTAL input is active and valid. When the V_{CC} is valid, but the other "required RESET duration" conditions (as specified above) have not been yet met, the device circuitry will not be in an initialized state that can result in significant power consumption and heat-up. Designs should minimize this state to the shortest possible duration.



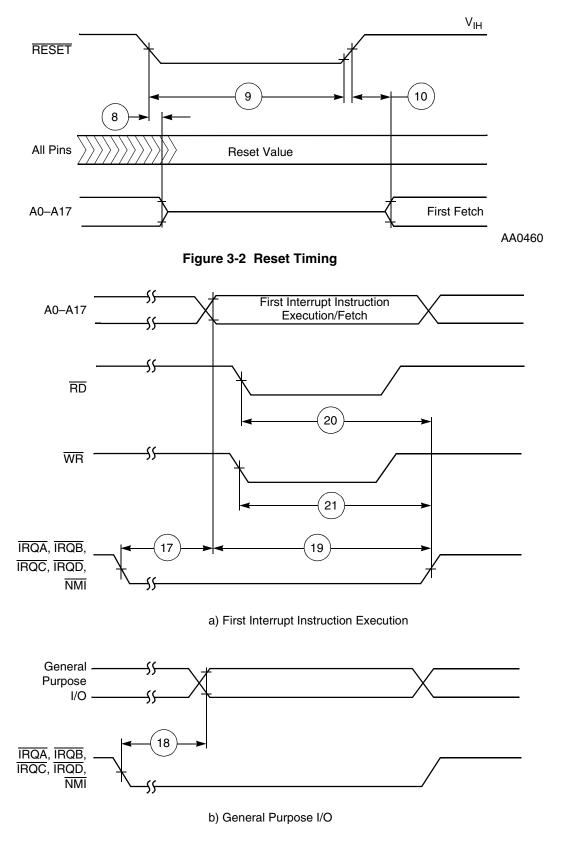
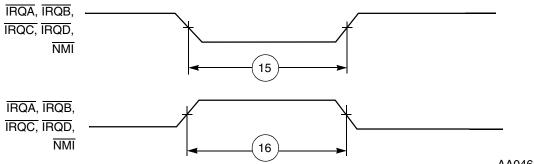


Figure 3-3 External Fast Interrupt Timing



AA0463



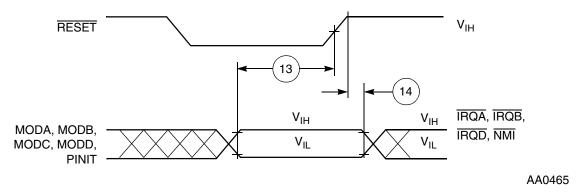


Figure 3-5 Operating Mode Select Timing

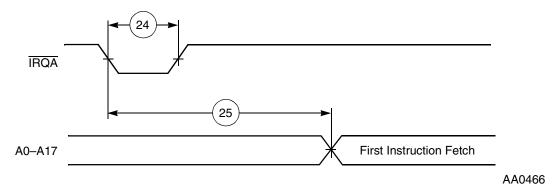
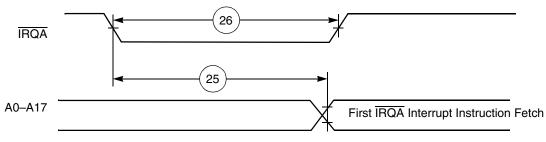


Figure 3-6 Recovery from Stop State Using IRQA Interrupt Service

DSP56367 Technical Data, Rev. 2.1

External Memory Expansion Port (Port A)



AA0467



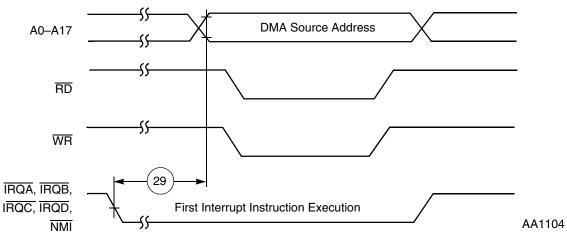
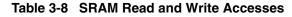


Figure 3-8 External Memory Access (DMA Source) Timing

3.10 External Memory Expansion Port (Port A)

3.10.1 SRAM Timing



No.	Characteristics	Symbol	Expression ¹	150 MHz		Unit
NO.	Characteristics	Symbol	Expression	Min	Max	
100	Address valid and AA assertion pulse width	t _{RC} , t _{WC}		22.7	_	ns
			$(WS + 3) \times T_C - 4.0 \ [WS \ge 8]$	69.3	—	ns
101	Address and AA valid to \overline{WR} assertion	t _{AS}	$0.75 \times T_{C} - 2.0[2 \le WS \le 3]$	3.0	_	ns
			$1.25 \times T_C - 2.0[WS \ge 4]$	6.3	—	ns
102	WR assertion pulse width	t _{WP}	$WS \times T_C - 4.0 \ [2 \le WS \le 3]$	9.3		ns
			$(WS-0.5)\times T_C-4.0[WS\geq 4]$	19.3	—	ns
103	WR deassertion to address not valid	t _{WR}	$1.25 \times T_C - 4.0[2 \le WS \le 7]$	4.3	_	ns
			$2.25 \times T_C - 4.0 [WS \ge 8]$	11.0	—	ns

No.	Characteristics	Symbol	Expression ¹	150	MHz	Unit
NO.	Characteristics	Symbol	Expression	Min	Max	Unit
104	Address and AA valid to input data valid	t _{AA} , t _{AC}	$(WS + 0.75) \times T_C - 5.0 [WS \ge 2]$	_	13.3	ns
105	RD assertion to input data valid	t _{OE}	$(WS + 0.25) \times T_C - 5.0 [WS \ge 2]$	_	10.0	ns
106	RD deassertion to data not valid (data hold time)	t _{OHZ}		0.0	_	ns
107	Address valid to \overline{WR} deassertion ²	t _{AW}	$(WS + 0.75) \times T_C - 4.0 [WS \ge 2]$	14.3	_	ns
108	Data valid to \overline{WR} deassertion (data setup time)	t _{DS} (t _{DW})	$(WS - 0.25) \times T_C - 3.0 \ [WS \ge 2]$	8.7	_	ns
109	Data hold time from \overline{WR} deassertion	t _{DH}	$1.25 \times T_C - 2.0[2 \le WS \le 7]$	6.3	—	ns
			$2.25 imes T_C - 2.0 \ [WS \ge 8]$	13.0	—	ns
110	WR assertion to data active	—	$0.25 \times T_C - 3.7 \; [2 \leq WS \leq 3]$	-2.0	—	ns
			$-0.25 \times T_C - 3.7 \text{ [WS } \ge 4\text{]}$	-5.4	—	ns
111	\overline{WR} deassertion to data high impedance	—	$0.25 \times T_C + 0.2 \; [2 \leq WS \leq 3]$	—	1.9	ns
			$1.25 \times T_{C} + 0.2 \ [4 \le WS \le 7]$	—	8.5	ns
			$2.25 \times T_{C} + 0.2 [WS \ge 8]$		15.2	ns
112	Previous RD deassertion to data active (write)	—	$1.25 \times T_C - 4.0 \ [2 \leq WS \leq 3]$	4.3	—	ns
			$2.25 \times T_C - 4.0 \; [4 \leq WS \leq 7]$	11.0	—	ns
			$3.25 imes T_C - 4.0 \ [WS \ge 8]$	17.7	—	ns
113	RD deassertion time		$1.75 \times T_C - 4.0 \ [2 \le WS \le 7]$	7.7		ns
			$2.75 imes T_C - 4.0 \ [WS \ge 8]$	14.3	—	ns
114	WR deassertion time		$2.0 \times T_{C} - 4.0 [2 \le WS \le 3]$	9.3		ns
			$2.5 imes T_C - 4.0 \; [4 \le WS \le 7]$	12.7	—	ns
			$3.5 imes T_C - 4.0 \; [WS \ge 8]$	19.3	—	ns
115	Address valid to RD assertion		$0.5 imes T_C - 2.0$	1.3	_	ns
116	RD assertion pulse width		$(WS + 0.25) \times T_{C} - 4.0$	11.0	_	ns
117	RD deassertion to address not valid		$1.25 \times T_C - 2.0 \ [2 \le WS \le 7]$	6.3	_	ns
			$2.25 imes T_C - 2.0 \ [WS \ge 8]$	13.0	—	ns
118	\overline{TA} setup before \overline{RD} or \overline{WR} deassertion ³		0.25 × T _C + 2.0	3.7	_	ns
119	\overline{TA} hold after \overline{RD} or \overline{WR} deassertion			0.0	_	ns

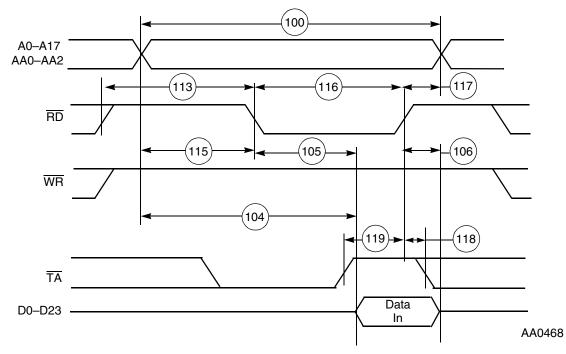
Table 3-8	SRAM Read and	Write Accesses	(continued)
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¹ WS is the number of wait states specified in the BCR. The value is given for the minimum for a given category. (For example, for a category of $[2 \le WS \le 7]$ timing is specified for 2 wait states.) Two wait states is the minimum otherwise.

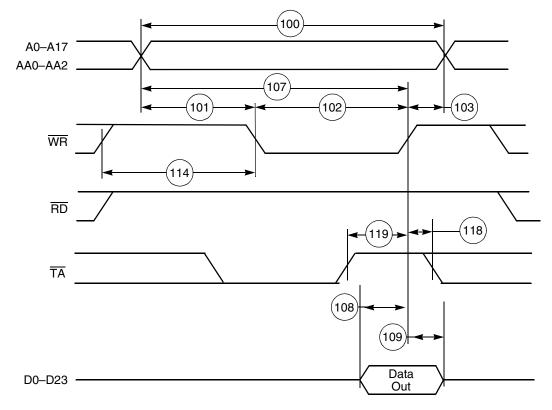
² Timings 100, 107 are guaranteed by design, not tested.

³ In the case of $\overline{\text{TA}}$ negation: timing 118 is relative to the deassertion edge of $\overline{\text{RD}}$ or WR were $\overline{\text{TA}}$ to remain active.

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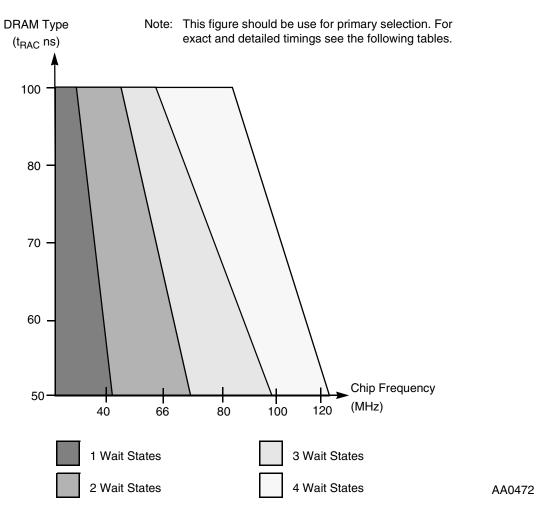




DSP56367 Technical Data, Rev. 2.1

3.10.2 DRAM Timing

The selection guides provided in Figure 3-11 and Figure 3-14 should be used for primary selection only. Final selection should be based on the timing provided in the following tables. As an example, the selection guide suggests that 4 wait states must be used for 100 MHz operation when using Page Mode DRAM. However, by using the information in the appropriate table, a designer may choose to evaluate whether fewer wait states might be used by determining which timing prevents operation at 100 MHz, running the chip at a slightly lower frequency (e.g., 95 MHz), using faster DRAM (if it becomes available), and control factors such as capacitive and resistive load to improve overall system performance.





DSP56367 Technical Data, Rev. 2.1

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No	Characteristics	Symbol	Expression ⁴	100	MHz	Unit
No.	Characteristics	Symbol	Expression	Min	Max	Unit
131	Page mode cycle time for two consecutive accesses of the same direction	t _{PC}	$2 \times T_{C}$	20.0	_	ns
	Page mode cycle time for mixed (read and write) accesses		$1.25 imes T_{C}$	12.5	—	
132	CAS assertion to data valid (read)	t _{CAC}	$2 \times T_C - 7.0$	_	13.0	ns
133	Column address valid to data valid (read)	t _{AA}	$3 imes T_C - 7.0$	_	23.0	ns
134	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0		ns
135	Last CAS assertion to RAS deassertion	t _{RSH}	$2.5 imes T_C - 4.0$	21.0	_	ns
136	Previous \overline{CAS} deassertion to \overline{RAS} deassertion	t _{RHCP}	$4.5 imes T_C - 4.0$	41.0		ns
137	CAS assertion pulse width	t _{CAS}	$2 \times T_C - 4.0$	16.0		ns
138	 Last CAS deassertion to RAS assertion⁵ BRW[1:0] = 00, 01— not applicable 	t _{CRP}				ns
	• BRW[1:0] = 10		$4.75 \times T_C - 6.0$	41.5	—	
	• BRW[1:0] = 11		$6.75\times T_C-6.0$	61.5	—	
139	CAS deassertion pulse width	t _{CP}	$1.5 imes T_{C} - 4.0$	11.0	_	ns
140	Column address valid to CAS assertion	t _{ASC}	T _C -4.0	6.0	_	ns
141	CAS assertion to column address not valid	t _{CAH}	$2.5 imes T_C - 4.0$	21.0	_	ns
142	Last column address valid to \overline{RAS} deassertion	t _{RAL}	$4 \times T_C - 4.0$	36.0	_	ns
143	$\overline{\text{WR}}$ deassertion to $\overline{\text{CAS}}$ assertion	t _{RCS}	$1.25 imes T_{C} - 4.0$	8.5	_	ns
144	CAS deassertion to WR assertion	t _{RCH}	$0.75 \times T_{C} - 4.0$	3.5		ns
145	CAS assertion to WR deassertion	t _{WCH}	$2.25 imes T_{C} - 4.2$	18.3	_	ns
146	WR assertion pulse width	t _{WP}	$3.5 imes T_C - 4.5$	30.5		ns
147	Last \overline{WR} assertion to \overline{RAS} deassertion	t _{RWL}	$3.75 imes T_{C} - 4.3$	33.2		ns
148	\overline{WR} assertion to \overline{CAS} deassertion	t _{CWL}	$3.25 imes T_{C} - 4.3$	28.2	_	ns
149	Data valid to CAS assertion (write)	t _{DS}	$0.5 imes T_C - 4.0$	1.0	_	ns
150	CAS assertion to data not valid (write)	t _{DH}	$2.5 imes T_C - 4.0$	21.0		ns
151	\overline{WR} assertion to \overline{CAS} assertion	t _{WCS}	$1.25 imes T_{C} - 4.3$	8.2	_	ns
152	Last $\overline{\text{RD}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{ROH}	$3.5 imes T_C - 4.0$	31.0	_	ns

 Table 3-9
 DRAM Page Mode Timings, Three Wait States^{1, 2, 3}

No.	Characteristics	Symbol	Expression ⁴	100 MHz		Unit
NO.	Characteristics	Symbol	Expression	Min	Max	
153	RD assertion to data valid	t _{GA}	$2.5 imes T_C - 7.0$	_	18.0	ns
154	RD deassertion to data not valid ⁶	t _{GZ}		0.0		ns
155	WR assertion to data active		$0.75\times T_C^{}-0.3$	7.2		ns
156	WR deassertion to data high impedance		$0.25 imes T_C$		2.5	ns

 Table 3-9
 DRAM Page Mode Timings, Three Wait States^{1, 2, 3} (continued)

¹ The number of wait states for Page mode access is specified in the DCR.

² The refresh period is specified in the DCR.

³ The asynchronous delays specified in the expressions are valid for DSP56367.

⁴ All the timings are calculated for the worst case. Some of the timings are better for specific cases (e.g., t_{PC} equals 4 × TC for read-after-read or write-after-write sequences).

⁵ BRW[1:0] (DRAM control register bits) defines the number of wait states that should be inserted in each DRAM out-of page-access.

⁶ \overline{RD} deassertion will always occur after \overline{CAS} deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ}.

No.	Characteristics	Symbol	Expression ⁴	100	MHz	Unit
NO.	Gharacteristics	Symbol	Expression	Min	Max	Omt
131	Page mode cycle time for two consecutive accesses of the same direction	t _{PC}	5 × T _C	50.0	_	ns
	Page mode cycle time for mixed (read and write) accesses		$4.5 \times T_{C}$	45.0	—	
132	CAS assertion to data valid (read)	t _{CAC}	$2.75 imes T_{C} - 5.7$	—	21.8	ns
133	Column address valid to data valid (read)	t _{AA}	$3.75 imes T_{C} - 5.7$	_	31.8	ns
134	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	ns
135	Last CAS assertion to RAS deassertion	t _{RSH}	$3.5 imes T_C - 4.0$	31.0	_	ns
136	Previous CAS deassertion to RAS deassertion	t _{RHCP}	$6 imes T_C - 4.0$	56.0	_	ns
137	CAS assertion pulse width	t _{CAS}	$2.5\times T_C-4.0$	21.0	—	ns
138	Last CAS deassertion to RAS assertion ⁵	t _{CRP}				
	 BRW[1–0] = 00, 01—Not applicable 		—	—		—
	• BRW[1–0] = 10		$5.25 imes T_{C} - 6.0$	46.5		ns
	• BRW[1–0] = 11		$7.25\times T_C-6.0$	66.5	—	ns
139	CAS deassertion pulse width	t _{CP}	$2 \times T_C - 4.0$	16.0	_	ns
140	Column address valid to CAS assertion	t _{ASC}	T _C – 4.0	6.0		ns

DSP56367 Technical Data, Rev. 2.1

No.	Characteristics	Symbol	Expression ⁴	100	MHz	Unit
NO.	Characteristics	Symbol	Expression ⁴	Min	Max	Unit
141	CAS assertion to column address not valid	t _{CAH}	$3.5 imes T_C - 4.0$	31.0	_	ns
142	Last column address valid to RAS deassertion	t _{RAL}	$5 imes T_C - 4.0$	46.0	_	ns
143	$\overline{\text{WR}}$ deassertion to $\overline{\text{CAS}}$ assertion	t _{RCS}	$1.25 imes T_C - 4.0$	8.5	_	ns
144	CAS deassertion to WR assertion	t _{RCH}	$1.25 imes T_{C} - 3.7$	8.8	_	ns
145	CAS assertion to WR deassertion	t _{WCH}	$3.25 imes T_C - 4.2$	28.3	_	ns
146	WR assertion pulse width	t _{WP}	$4.5 imes T_C - 4.5$	40.5	_	ns
147	Last \overline{WR} assertion to \overline{RAS} deassertion	t _{RWL}	$4.75\times T_C-4.3$	43.2	_	ns
148	WR assertion to CAS deassertion	t _{CWL}	$3.75 imes T_C - 4.3$	33.2	—	ns
149	Data valid to CAS assertion (write)	t _{DS}	$0.5 imes T_C - 4.5$	0.5	_	ns
150	CAS assertion to data not valid (write)	t _{DH}	$3.5 imes T_C - 4.0$	31.0	_	ns
151	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$1.25 imes T_C - 4.3$	8.2	_	ns
152	Last $\overline{\text{RD}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{ROH}	$4.5\times T_C-4.0$	41.0	_	ns
153	RD assertion to data valid	t _{GA}	$3.25\times T_C-5.7$	_	26.8	ns
154	RD deassertion to data not valid ⁶	t _{GZ}		0.0	_	ns
155	WR assertion to data active		$0.75 imes T_{C} - 1.5$	6.0	_	ns
156	WR deassertion to data high impedance		$0.25 imes T_C$	_	2.5	ns

 Table 3-10
 DRAM Page Mode Timings, Four Wait States^{1, 2, 3} (continued)

¹ The number of wait states for Page mode access is specified in the DCR.

 2 The refresh period is specified in the DCR.

³ The asynchronous delays specified in the expressions are valid for DSP56367.

⁴ All the timings are calculated for the worst case. Some of the timings are better for specific cases (for example, t_{PC} equals $3 \times T_C$ for read-after-read or write-after-write sequences). An expressions is used to calculate the maximum or minimum value listed, as appropriate.

⁵ BRW[1–0] (DRAM control register bits) defines the number of wait states that should be inserted in each DRAM out-of-page access.

⁶ $\overline{\text{RD}}$ deassertion always occurs after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ}.

External Memory Expansion Port (Port A)

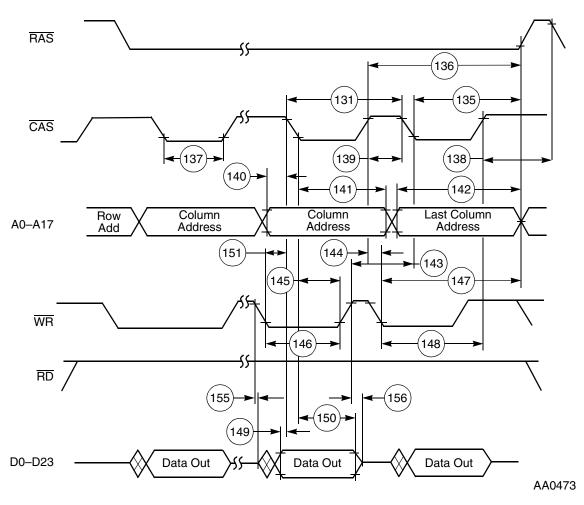


Figure 3-12 DRAM Page Mode Write Accesses

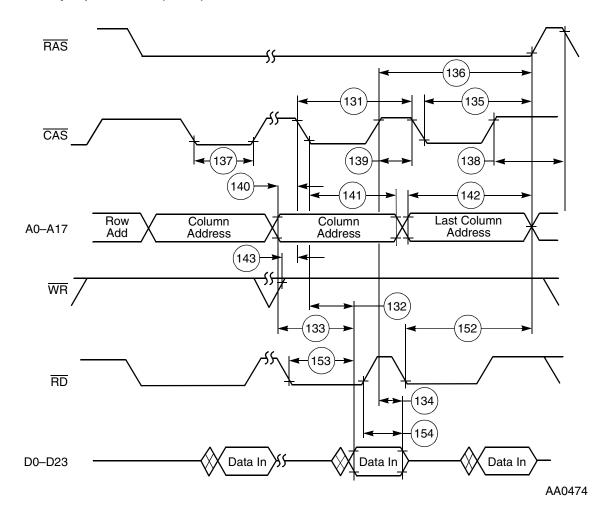


Figure 3-13 DRAM Page Mode Read Accesses

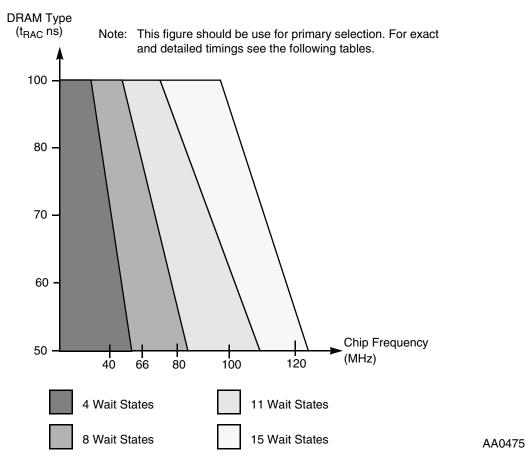


Figure 3-14 DRAM Out-of-Page Wait States Selection Guide

No.	Characteristics	Symbol	Expression	20 MHz ³		30 MHz ³		Unit
110.	Undracteristics	Symbol	Expression	Min	Мах	Min	Max	onic
157	Random read or write cycle time	t _{RC}	$5 \times T_{C}$	250.0		166.7		ns
158	RAS assertion to data valid (read)	t _{RAC}	$2.75 imes T_{C} - 7.5$	_	130.0	_	84.2	ns
159	CAS assertion to data valid (read)	t _{CAC}	$1.25 imes T_{C} - 7.5$		55.0	_	34.2	ns
160	Column address valid to data valid (read)	t _{AA}	$1.5 imes T_{C} - 7.5$	_	67.5	_	42.5	ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	0.0		ns
162	RAS deassertion to RAS assertion	t _{RP}	$1.75 imes T_{C} - 4.0$	83.5		54.3	_	ns
163	RAS assertion pulse width	t _{RAS}	$3.25\times T_C-4.0$	158.5	_	104.3	_	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$1.75 imes T_{C} - 4.0$	83.5		54.3		ns

Table 3-11 DF	RAM Out-of-Page and R	efresh Timings, Fou	r Wait States ^{1, 2}
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DSP56367 Technical Data, Rev. 2.1

No.	Characteristics	Symbol	Expression	20 N	/Hz ³	30 MHz ³		Unit
NO.	Characteristics	Symbol	Expression	Min	Max	Min	Max	Unit
165	RAS assertion to CAS deassertion	t _{CSH}	$2.75 imes T_{C} - 4.0$	133.5	_	87.7	_	ns
166	CAS assertion pulse width	t _{CAS}	$1.25 imes T_{C} - 4.0$	58.5	—	37.7	—	ns
167	RAS assertion to CAS assertion	t _{RCD}	$1.5 imes T_{C} \pm 2$	73.0	77.0	48.0	52.0	ns
168	RAS assertion to column address valid	t _{RAD}	$1.25 \times T_{C} \pm 2$	60.5	64.5	39.7	43.7	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$2.25 imes T_{C} - 4.0$	108.5	_	71.0	_	ns
170	CAS deassertion pulse width	t _{CP}	$1.75 imes T_{C} - 4.0$	83.5	_	54.3	—	ns
171	Row address valid to RAS assertion	t _{ASR}	$1.75 imes T_{C} - 4.0$	83.5	_	54.3	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$1.25 imes T_{C} - 4.0$	58.5	_	37.7	—	ns
173	Column address valid to CAS assertion	t _{ASC}	$0.25 imes T_{C} - 4.0$	8.5	_	4.3	—	ns
174	CAS assertion to column address not valid	t _{CAH}	$1.75 imes T_{C} - 4.0$	83.5	_	54.3	_	ns
175	RAS assertion to column address not valid	t _{AR}	$3.25 imes T_{C} - 4.0$	158.5	_	104.3	—	ns
176	Column address valid to RAS deassertion	t _{RAL}	$2 \times T_C - 4.0$	96.0	_	62.7	—	ns
177	$\overline{\rm WR}$ deassertion to $\overline{\rm CAS}$ assertion	t _{RCS}	$1.5 imes T_{C} - 3.8$	71.2	_	46.2	_	ns
178	CAS deassertion to WR assertion	t _{RCH}	$0.75 imes T_{C} - 3.7$	33.8	—	21.3	—	ns
179	RAS deassertion to WR assertion	t _{RRH}	$0.25 imes T_{C} - 3.7$	8.8	—	4.6	—	ns
180	\overline{CAS} assertion to \overline{WR} deassertion	t _{WCH}	$1.5 imes T_{C} - 4.2$	70.8	—	45.8	—	ns
181	RAS assertion to WR deassertion	t _{WCR}	$3 \times T_{C} - 4.2$	145.8	_	95.8	—	ns
182	WR assertion pulse width	t _{WP}	$4.5 imes T_C - 4.5$	220.5	—	145.5	—	ns
183	$\overline{\text{WR}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RWL}	$4.75 imes T_{C} - 4.3$	233.2	_	154.0	—	ns
184	\overline{WR} assertion to \overline{CAS} deassertion	t _{CWL}	$4.25 imes T_{C} - 4.3$	208.2	—	137.4	—	ns
185	Data valid to CAS assertion (write)	t _{DS}	$2.25\times T_C-4.0$	108.5	—	71.0	—	ns
186	CAS assertion to data not valid (write)	t _{DH}	$1.75 imes T_{C} - 4.0$	83.5		54.3		ns
187	RAS assertion to data not valid (write)	t _{DHR}	$3.25 imes T_C - 4.0$	158.5	_	104.3	_	ns
188	\overline{WR} assertion to \overline{CAS} assertion	twcs	$3 imes T_C - 4.3$	145.7		95.7	_	ns
189	CAS assertion to RAS assertion (refresh)	t _{CSR}	$0.5 imes T_C - 4.0$	21.0	_	12.7	_	ns
190	RAS deassertion to CAS assertion (refresh)	t _{RPC}	$1.25 imes T_{C} - 4.0$	58.5	_	37.7	_	ns

 Table 3-11
 DRAM Out-of-Page and Refresh Timings, Four Wait States^{1, 2} (continued)

DSP56367 Technical Data, Rev. 2.1

No.	Characteristics	Symbol	Expression	20 N	/Hz ³	30 MHz ³		Unit
NO.	Characteristics	Symbol	Expression	Min	Max	Min	Max	Unit
191	RD assertion to RAS deassertion	t _{ROH}	$4.5 imes T_C - 4.0$	221.0	_	146.0	_	ns
192	RD assertion to data valid	t _{GA}	$4 imes T_C - 7.5$		192.5		125.8	ns
193	RD deassertion to data not valid ⁴	t _{GZ}		0.0	_	0.0	_	ns
194	WR assertion to data active		$0.75 imes T_C - 0.3$	37.2	_	24.7	_	ns
195	WR deassertion to data high impedance		$0.25 imes T_C$	_	12.5	_	8.3	ns

 Table 3-11
 DRAM Out-of-Page and Refresh Timings, Four Wait States^{1, 2} (continued)

¹ The number of wait states for out of page access is specified in the DCR.

² The refresh period is specified in the DCR.

³ Reduced DSP clock speed allows use of DRAM out-of-page access with four Wait states (Figure 3-14).

⁴ $\overline{\text{RD}}$ deassertion will always occur after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ}.

	Oherneterieties	0h.el	Francisco	100	Unit	
No.	Characteristics	Symbol	Expression	Min	Max	Unit
157	Random read or write cycle time	t _{RC}	$12 \times T_{C}$	120.0	_	ns
158	RAS assertion to data valid (read)	t _{RAC}	$6.25 imes T_{C} - 7.0$	—	55.5	ns
159	CAS assertion to data valid (read)	t _{CAC}	$3.75 imes T_{C} - 7.0$	—	30.5	ns
160	Column address valid to data valid (read)	t _{AA}	$4.5 imes T_C - 7.0$	—	38.0	ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	ns
162	RAS deassertion to RAS assertion	t _{RP}	$4.25 imes T_{C} - 4.0$	38.5	_	ns
163	RAS assertion pulse width	t _{RAS}	$7.75 imes T_{C} - 4.0$	73.5	_	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$5.25 imes T_{C} - 4.0$	48.5	_	ns
165	RAS assertion to CAS deassertion	t _{CSH}	$6.25 imes T_{C} - 4.0$	58.5	_	ns
166	CAS assertion pulse width	t _{CAS}	$3.75 imes T_{C} - 4.0$	33.5	_	ns
167	RAS assertion to CAS assertion	t _{RCD}	$2.5 imes T_C \pm 4.0$	21.0	29.0	ns
168	RAS assertion to column address valid	t _{RAD}	$1.75 imes T_{C} \pm 4.0$	13.5	21.5	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$5.75 imes T_{C} - 4.0$	53.5	_	ns
170	CAS deassertion pulse width	t _{CP}	$4.25 imes T_{C} - 4.0$	38.5	_	ns
171	Row address valid to RAS assertion	t _{ASR}	$4.25 imes T_{C} - 4.0$	38.5	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$1.75 imes T_{C} - 4.0$	13.5	_	ns

Table 3-12 DRAM Out-of-Page and Refresh Timings, Eleven Wait States^{1, 2, 3}

DSP56367 Technical Data, Rev. 2.1

Na	Ohavestavistics	Cumbal	Furnissian	100	Unit	
No.	Characteristics	Symbol	Expression	Min	Max	Unit
173	Column address valid to CAS assertion	t _{ASC}	$0.75 imes T_C - 4.0$	3.5		ns
174	CAS assertion to column address not valid	t _{CAH}	$5.25 imes T_{C} - 4.0$	48.5		ns
175	RAS assertion to column address not valid	t _{AR}	$7.75 imes T_{C} - 4.0$	73.5	_	ns
176	Column address valid to RAS deassertion	t _{RAL}	$6 imes T_C - 4.0$	56.0	_	ns
177	WR deassertion to CAS assertion	t _{RCS}	$3.0 imes T_C - 4.0$	26.0	_	ns
178	\overline{CAS} deassertion to \overline{WR}^4 assertion	t _{RCH}	$1.75 imes T_{C} - 4.0$	13.5	_	ns
179	\overline{RAS} deassertion to \overline{WR}^4 assertion	t _{RRH}	$0.25 imes T_{C} - 2.0$	0.5	_	ns
180	\overline{CAS} assertion to \overline{WR} deassertion	t _{WCH}	$5 imes T_C - 4.2$	45.8	_	ns
181	\overline{RAS} assertion to \overline{WR} deassertion	t _{WCR}	$7.5 imes T_{C} - 4.2$	70.8	_	ns
182	WR assertion pulse width	t _{WP}	$11.5 imes T_{C} - 4.5$	110.5	_	ns
183	WR assertion to RAS deassertion	t _{RWL}	$11.75 imes T_{C} - 4.3$	113.2	_	ns
184	\overline{WR} assertion to \overline{CAS} deassertion	t _{CWL}	$10.25 imes T_{C} - 4.3$	103.2		ns
185	Data valid to CAS assertion (write)	t _{DS}	$5.75 imes T_{C} - 4.0$	53.5		ns
186	CAS assertion to data not valid (write)	t _{DH}	$5.25 imes T_{C} - 4.0$	48.5		ns
187	RAS assertion to data not valid (write)	t _{DHR}	$7.75 imes T_{C} - 4.0$	73.5		ns
188	WR assertion to CAS assertion	t _{wcs}	$6.5 imes T_C - 4.3$	60.7		ns
189	CAS assertion to RAS assertion (refresh)	t _{CSR}	$1.5 imes T_C - 4.0$	11.0		ns
190	\overline{RAS} deassertion to \overline{CAS} assertion (refresh)	t _{RPC}	$2.75 imes T_{C} - 4.0$	23.5	_	ns
191	RD assertion to RAS deassertion	t _{ROH}	$11.5 imes T_{C} - 4.0$	111.0	_	ns
192	RD assertion to data valid	t _{GA}	$10 \times T_{C} - 7.0$	—	93.0	ns
193	RD deassertion to data not valid ⁵	t _{GZ}		0.0	_	ns
194	WR assertion to data active		$0.75\times T_C^{}-0.3$	7.2	_	ns
195	WR deassertion to data high impedance		$0.25 imes T_{C}$	—	2.5	ns

 Table 3-12
 DRAM Out-of-Page and Refresh Timings, Eleven Wait States^{1, 2, 3} (continued)

¹ The number of wait states for out-of-page access is specified in the DCR.

 2 The refresh period is specified in the DCR.

³ The asynchronous delays specified in the expressions are valid for DSP56367.

⁴ Either t_{BCH} or t_{BBH} must be satisfied for read cycles.

⁵ $\overline{\text{RD}}$ deassertion will always occur after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ}.

N -	Ob any stanistics	0h.al	F	100	MHz	
No.	Characteristics	Symbol	Expression ³	Min	Max	- Unit
157	Random read or write cycle time	t _{RC}	$16 \times T_{C}$	160.0	_	ns
158	RAS assertion to data valid (read)	t _{RAC}	$8.25 imes T_{C} - 5.7$	_	76.8	ns
159	CAS assertion to data valid (read)	t _{CAC}	$4.75 imes T_{C} - 5.7$	—	41.8	ns
160	Column address valid to data valid (read)	t _{AA}	$5.5 imes T_{C}-5.7$	_	49.3	ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}	0.0	0.0	_	ns
162	RAS deassertion to RAS assertion	t _{RP}	$6.25 imes T_{C} - 4.0$	58.5	_	ns
163	RAS assertion pulse width	t _{RAS}	$9.75 imes T_{C} - 4.0$	93.5	_	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$6.25 imes T_{C} - 4.0$	58.5	_	ns
165	RAS assertion to CAS deassertion	t _{CSH}	$8.25 imes T_C - 4.0$	78.5	_	ns
166	CAS assertion pulse width	t _{CAS}	$4.75\times T_C-4.0$	43.5	_	ns
167	RAS assertion to CAS assertion	t _{RCD}	$3.5 imes T_C \pm 2$	33.0	37.0	ns
168	RAS assertion to column address valid	t _{RAD}	$2.75 imes T_C \pm 2$	25.5	29.5	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$7.75 imes T_{C} - 4.0$	73.5	_	ns
170	CAS deassertion pulse width	t _{CP}	$6.25 imes T_{C} - 6.0$	56.5	_	ns
171	Row address valid to RAS assertion	t _{ASR}	$6.25 imes T_{C} - 4.0$	58.5	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$2.75 imes T_{C} - 4.0$	23.5	_	ns
173	Column address valid to CAS assertion	t _{ASC}	$0.75 imes T_{C} - 4.0$	3.5	_	ns
174	CAS assertion to column address not valid	t _{CAH}	$6.25 imes T_{C} - 4.0$	58.5	_	ns
175	RAS assertion to column address not valid	t _{AR}	$9.75 imes T_{C} - 4.0$	93.5	_	ns
176	Column address valid to RAS deassertion	t _{RAL}	$7 imes T_C - 4.0$	66.0		ns
177	WR deassertion to CAS assertion	t _{RCS}	$5 imes T_C - 3.8$	46.2	_	ns
178	\overline{CAS} deassertion to \overline{WR}^4 assertion	t _{RCH}	$1.75 imes T_{C} - 3.7$	13.8	_	ns
179	\overline{RAS} deassertion to \overline{WR}^4 assertion	t _{RRH}	$0.25 imes T_C - 2.0$	0.5	_	ns
180	\overline{CAS} assertion to \overline{WR} deassertion	t _{WCH}	$6 imes T_C - 4.2$	55.8	—	ns
181	\overline{RAS} assertion to \overline{WR} deassertion	t _{WCR}	$9.5 imes T_C - 4.2$	90.8	—	ns
182	WR assertion pulse width	t _{WP}	$15.5 imes T_{C} - 4.5$	150.5	_	ns

Table 3-13 DRAM Out-of-Page and Refresh Timings, Fifteen Wait States^{1, 2}

DSP56367 Technical Data, Rev. 2.1

No.	Characteristics	Symbol	Expression ³	100 MHz		Unit
NO.	Characteristics	Symbol	Expression	Min	Max	Unit
183	WR assertion to RAS deassertion	t _{RWL}	$15.75 imes T_{C} - 4.3$	153.2	_	ns
184	WR assertion to CAS deassertion	t _{CWL}	$14.25 imes T_{C} - 4.3$	138.2	—	ns
185	Data valid to \overline{CAS} assertion (write)	t _{DS}	$8.75 imes T_{C} - 4.0$	83.5	—	ns
186	CAS assertion to data not valid (write)	t _{DH}	$6.25 imes T_{C} - 4.0$	58.5	—	ns
187	RAS assertion to data not valid (write)	t _{DHR}	$9.75 imes T_{C} - 4.0$	93.5	—	ns
188	WR assertion to CAS assertion	t _{WCS}	$9.5 imes T_C - 4.3$	90.7	—	ns
189	CAS assertion to RAS assertion (refresh)	t _{CSR}	$1.5 imes T_C - 4.0$	11.0	—	ns
190	RAS deassertion to CAS assertion (refresh)	t _{RPC}	$4.75 \times T_C - 4.0$	43.5	—	ns
191	$\overline{\text{RD}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{ROH}	$15.5 imes T_{C} - 4.0$	151.0	—	ns
192	RD assertion to data valid	t _{GA}	$14 imes T_C - 5.7$	_	134.3	ns
193	$\overline{\text{RD}}$ deassertion to data not valid ⁵	t _{GZ}		0.0	—	ns
194	WR assertion to data active		$0.75 imes T_{C} - 1.5$	6.0	—	ns
195	WR deassertion to data high impedance		$0.25 \times T_{C}$	—	2.5	ns

 Table 3-13
 DRAM Out-of-Page and Refresh Timings, Fifteen Wait States^{1, 2} (continued)

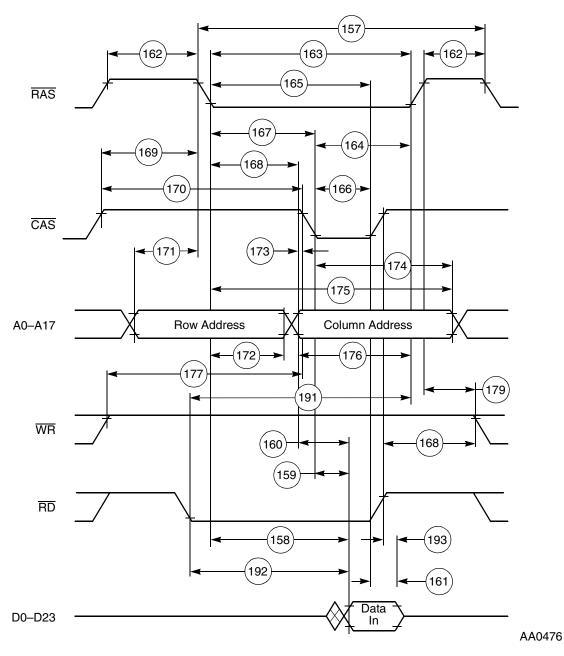
¹ The number of wait states for an out-of-page access is specified in the DCR.

 2 The refresh period is specified in the DCR.

³ An expression is used to compute the maximum or minimum value listed (or both if the expression includes ±).

 4 Either t_{RCH} or t_{RRH} must be satisfied for read cycles.

⁵ $\overline{\text{RD}}$ deassertion always occurs after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ}.





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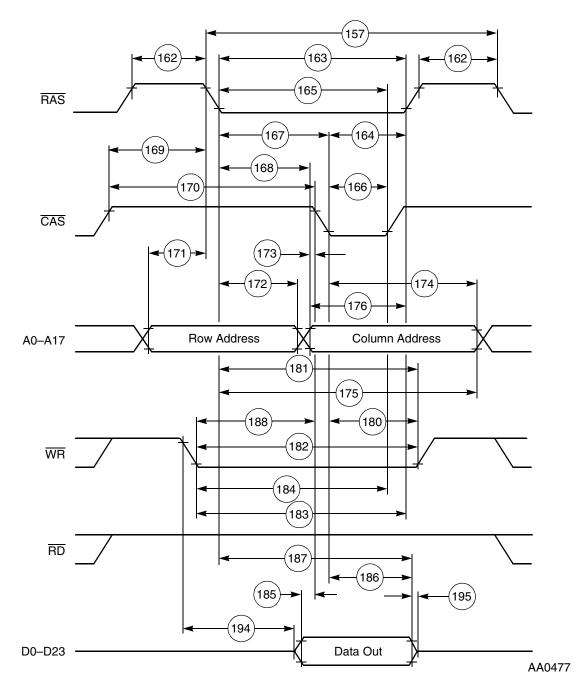


Figure 3-16 DRAM Out-of-Page Write Access

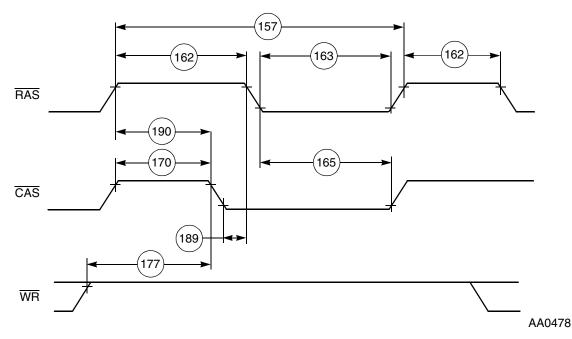


Figure 3-17 DRAM Refresh Access

3.10.3 Arbitration Timings

Table 3-14	Asynchronous	Bus	Arbitration	Timing ^{1, 2, 3}
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No.	Characteristics	Expression	150	Unit	
	Characteristics	Expression	Min	Мах	Onit
250	\overline{BB} assertion window from \overline{BG} input negation.	2 .5* Tc + 5	_	21.7	ns
251	Delay from \overline{BB} assertion to \overline{BG} assertion	2 * Tc + 5	18.3		ns

¹ Bit 13 in the OMR register must be set to enter Asynchronous Arbitration mode.

 2 If Asynchronous Arbitration mode is active, none of the timings in Table 3-14 is required.

³ In order to guarantee timings 250, and 251, it is recommended to assert \overline{BG} inputs to different 56300 devices (on the same bus) in a non overlap manner as shown in Figure 3-18.

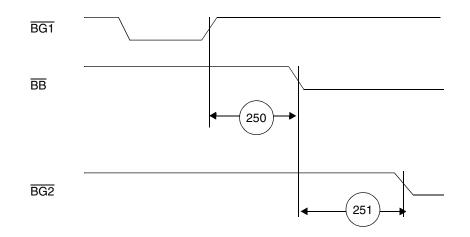


Figure 3-18 Asynchronous Bus Arbitration Timing

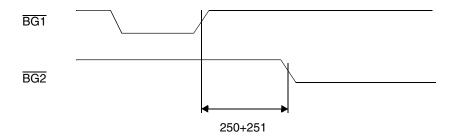


Figure 3-19 Asynchronous Bus Arbitration Timing

3.10.4 Background explanation for Asynchronous Bus Arbitration:

The asynchronous bus arbitration is enabled by internal synchronization circuits on \overline{BG} and \overline{BB} inputs. These synchronization circuits add delay from the external signal until it is exposed to internal logic. As a result of this delay, a 56300 part may assume mastership and assert \overline{BB} for some time after \overline{BG} is negated. This is the reason for timing 250.

Once \overline{BB} is asserted, there is a synchronization delay from \overline{BB} assertion to the time this assertion is exposed to other 56300 components which are potential masters on the same bus. If \overline{BG} input is asserted before that time, a situation of \overline{BG} asserted, and \overline{BB} negated, may cause another 56300 component to assume mastership at the same time. Therefore some non-overlap period between one \overline{BG} input active to another \overline{BG} input active is required. Timing 251 ensures that such a situation is avoided.

No.	Characteristics	Everagion	150	MHz	Unit
NO.	Characteristics	Expression	Min	Мах	Unit
317	Read data strobe assertion width ⁴ HACK read assertion width	T _C + 9.9	16.7	—	ns
318	Read data strobe deassertion width ⁴ HACK read deassertion width	_	9.9		ns
319	Read data strobe deassertion width ⁴ after "Last Data Register" reads ^{5, 6} , or between two consecutive CVR, ICR, or ISR reads ⁷ HACK deassertion width after "Last Data Register" reads ^{5, 6}	$2.5 \times T_{C} + 6.6$	23.3	_	ns
320	Write data strobe assertion width ⁸ HACK write assertion width	_	13.2	_	ns
321	 Write data strobe deassertion width⁸ HACK write deassertion width after ICR, CVR and "Last Data Register" writes⁵ after IVR writes, or after TXH:TXM writes (with HBE=0), or after TXL:TXM writes (with HBE=1) 	2.5 × T _C + 6.6	23.3 16.5	_	ns
322	HAS assertion width	—	9.9	—	ns
323	HAS deassertion to data strobe assertion ⁹	—	0.0	—	ns
324	Host data input setup time before write data strobe deassertion ⁸ Host data input setup time before HACK write deassertion	_	9.9		ns
325	Host data input hold time after write data strobe deassertion ⁸ Host data input hold time after $\overline{\text{HACK}}$ write deassertion	_	3.3		ns
326	Read data strobe assertion to output data active from high impedance ⁴ HACK read assertion to output data active from high impedance	_	3.3		ns
327	Read data strobe assertion to output data valid ⁴ HACK read assertion to output data valid	_	_	24.2	ns
328	Read data strobe deassertion to output data high impedance ⁴ HACK read deassertion to output data high impedance	_	_	9.9	ns
329	Output data hold time after read data strobe deassertion ⁴ Output data hold time after HACK read deassertion	_	3.3	_	ns
330	HCS assertion to read data strobe deassertion ⁴	T _C +9.9	16.7	—	ns
331	HCS assertion to write data strobe deassertion ⁸	—	9.9	—	ns

 Table 3-15
 Host Interface (HDI08)
 Timing^{1, 2, 3}

DSP56367 Technical Data, Rev. 2.1

No.	Characteristics	Expression	150	Unit	
NO.	Characteristics	Expression	Min	Max	Unit
332	HCS assertion to output data valid		—	19.1	ns
333	HCS hold time after data strobe deassertion ⁹	_	0.0	—	ns
334	Address (AD7–AD0) setup time before HAS deassertion (HMUX=1)	—	4.7	—	ns
335	Address (AD7–AD0) hold time after HAS deassertion (HMUX=1)	_	3.3	—	ns
336	A10-A8 (HMUX=1), A2-A0 (HMUX=0), HR/W setup time before data strobe assertion ⁹				ns
	• Read	—	0		
	• Write		4.7	—	
337	A10–A8 (HMUX=1), A2–A0 (HMUX=0), HR/ \overline{W} hold time after data strobe deassertion ⁹	_	3.3	_	ns
338	Delay from read data strobe deassertion to host request assertion for "Last Data Register" read ^{4, 5, 10}	Т _С	6.7	_	ns
339	Delay from write data strobe deassertion to host request assertion for "Last Data Register" write ^{5, 8, 10}	$2 \times T_{C}$	13.4	_	ns
340	Delay from data strobe assertion to host request deassertion for "Last Data Register" read or write $(HROD = 0)^{5, 9, 10}$	_	_	19.1	ns
341	Delay from data strobe assertion to host request deassertion for "Last Data Register" read or write (HROD = 1, open drain Host Request) ^{5, 9, 10, 11}	_	_	300.0	ns
342	Delay from DMA HACK deassertion to HOREQ assertion				ns
	 For "Last Data Register" read⁵ 	2×T _C +19.1	32.5		
	 For "Last Data Register" write⁵ 	$1.5 imes T_{C} + 19.1$	29.2	—	
	For other cases		0.0	—	
343	Delay from DMA HACK assertion to HOREQ deassertion • HROD = 0 ⁵	—	_	20.2	ns
344	 Delay from DMA HACK assertion to HOREQ deassertion for "Last Data Register" read or write HROD = 1, open drain Host Request^{5, 11} 	—	—	300.0	ns

 Table 3-15
 Host Interface (HDI08)
 Timing^{1, 2, 3} (continued)

¹ See Host Port Usage Considerations in the DSP56367 User's Manual.

² In the timing diagrams below, the controls pins are drawn as active low. The pin polarity is programmable.

 $^3~V_{CC}$ = 1.8 V ± 5%; T_J = –40°C to +95°C, C_L = 50 pF

⁴ The read data strobe is HRD in the dual data strobe mode and HDS in the single data strobe mode.

⁵ The "last data register" is the register at address \$7, which is the last location to be read or written in data transfers.

⁶ This timing is applicable only if a read from the "last data register" is followed by a read from the RXL, RXM, or RXH registers without first polling RXDF or HREQ bits, or waiting for the assertion of the HOREQ signal.

⁷ This timing is applicable only if two consecutive reads from one of these registers are executed.

⁸ The write data strobe is HWR in the dual data strobe mode and HDS in the single data strobe mode.

⁹ The data strobe is host read (HRD) or host write (HWR) in the dual data strobe mode and host data strobe (HDS) in the single data strobe mode.

¹⁰ The host request is HOREQ in the single host request mode and HRRQ and HTRQ in the double host request mode.

¹¹ In this calculation, the host request signal is pulled up by a 4.7 k Ω resistor in the open-drain mode.

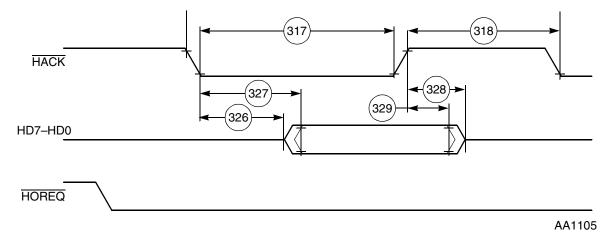
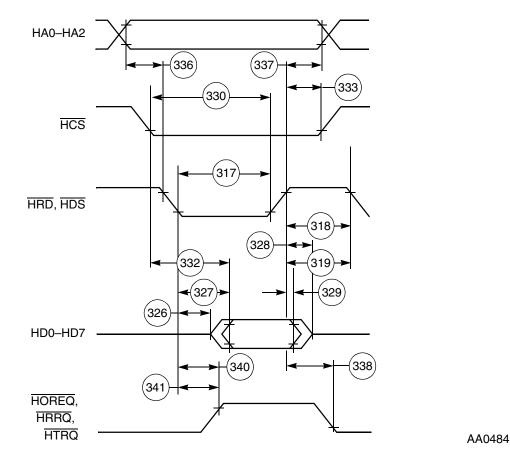


Figure 3-20 Host Interrupt Vector Register (IVR) Read Timing Diagram





DSP56367 Technical Data, Rev. 2.1

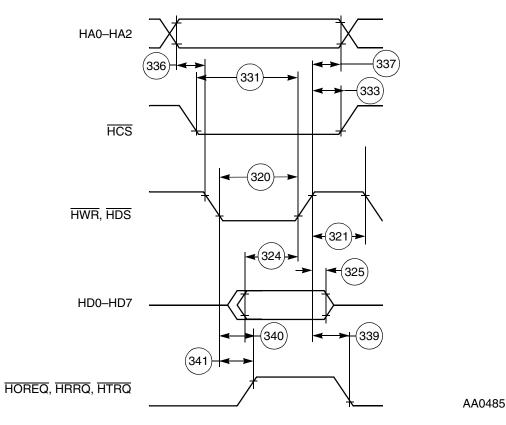


Figure 3-22 Write Timing Diagram, Non-Multiplexed Bus

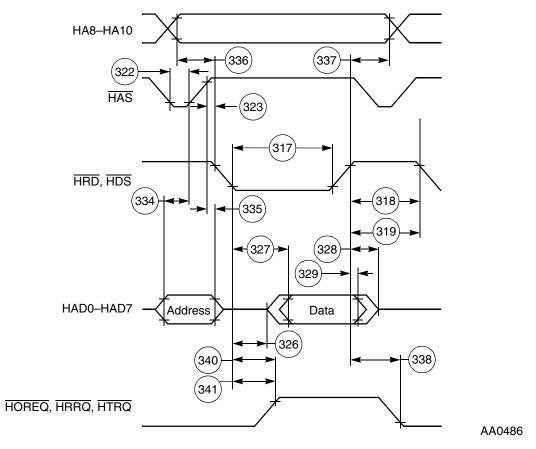


Figure 3-23 Read Timing Diagram, Multiplexed Bus

3-35

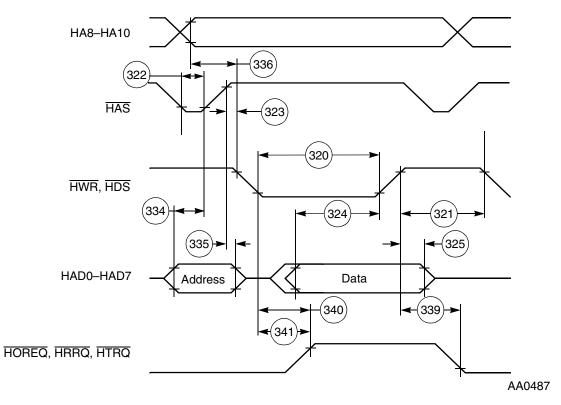


Figure 3-24 Write Timing Diagram, Multiplexed Bus

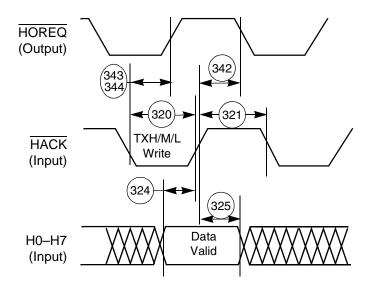


Figure 3-25 Host DMA Write Timing Diagram

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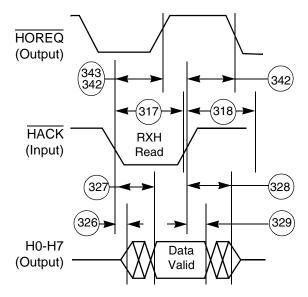


Figure 3-26 Host DMA Read Timing Diagram

3.12 Serial Host Interface SPI Protocol Timing

No.	Characteristics ¹	Mode	Filter Mode	Expression ²	Min	Мах	Unit
140	Tolerable spike width on clock or data in	_	Bypassed	—	_	0	ns
			Narrow	—	—	50	
			Wide	—	—	100	
141	Minimum serial clock cycle = t _{SPICC} (min)	Master	Bypassed	6×TC+46	86.2		ns
			Narrow	$6 \times T_{C}$ +152	192.2	—	
			Wide	$6 \times T_{C}$ +223	263.2	—	
142	Serial clock high period	Master	Bypassed	$0.5 \times t_{SPICC} - 10$	38	—	ns
			Narrow	$0.5 imes t_{SPICC} - 10$	91	—	
			Wide	$0.5 imes t_{SPICC} - 10$	126.5	—	
		Slave	Bypassed	2.5 × T _C + 12	28.8	—	ns
			Narrow	2.5 × T _C + 102	118.8	—	
			Wide	2.5 × T _C + 189	205.8	—	
143	Serial clock low period	Master	Bypassed	$0.5 \times t_{SPICC} - 10$	38		ns
			Narrow	$0.5 imes t_{SPICC} - 10$			
			Wide	$0.5 imes t_{SPICC} - 10$			
		Slave	Bypassed	2.5 × T _C + 12	28.8	_	ns
			Narrow	$2.5 \times T_{C} + 102$	118.8	—	
			Wide	$2.5 imes T_{C} + 189$	205.8	—	

Table 3-16 Serial Host Interface SPI Protocol Timing

DSP56367 Technical Data, Rev. 2.1

Serial Host Interface SPI Protocol Timing

No.	Characteristics ¹	Mode	Filter Mode	Expression ²	Min	Max	Unit
144	Serial clock rise/fall time	Master Slave			_	10 2000	ns
146	SS assertion to first SCK edge CPHA = 0	Slave	Bypassed Narrow Wide	$3.5 \times T_{C} + 15$ 0 0	38.5 0 0		ns
	CPHA = 1	Slave	Bypassed Narrow Wide	10 0 0	10 0 0		ns
147	Last SCK edge to SS not asserted	Slave	Bypassed Narrow Wide	12 102 189	12 102 189		ns
148	Data input valid to SCK edge (data input set-up time)	Master/ Slave	Bypassed Narrow Wide	0 MAX{(20-T _C), 0} MAX{(40-T _C), 0}	0 13.3 33.3		ns
149	SCK last sampling edge to data input not valid	Master/ Slave	Bypassed Narrow Wide	$2.5 \times T_{C} + 10$ $2.5 \times T_{C} + 30$ $2.5 \times T_{C} + 50$	26.8 46.8 66.8		ns
150	SS assertion to data out active	Slave	_	2	2	_	ns
151	SS deassertion to data high impedance ³	Slave	_	9	—	9	ns
152	SCK edge to data out valid (data out delay time)	Master/ Slave	Bypassed Narrow Wide	$2 \times T_{C} + 33$ $2 \times T_{C} + 123$ $2 \times T_{C} + 210$		46.4 136.4 223.4	ns
153	SCK edge to data out not valid (data out hold time)	Master/ Slave	Bypassed Narrow Wide	T _C + 5 T _C + 55 T _C + 106	11.7 61.7 112.7		ns
154	\overline{SS} assertion to data out valid (CPHA = 0)	Slave	_	T _C + 33	—	39.7	ns
157	First SCK sampling edge to HREQ output deassertion	Slave	Bypassed Narrow Wide	$2.5 \times T_{C} + 30$ $2.5 \times T_{C} + 120$ $2.5 \times T_{C} + 217$		46.8 136.8 233.8	ns
158	Last SCK sampling edge to HREQ output not deasserted (CPHA = 1)	Slave	Bypassed Narrow Wide	$2.5 \times T_{C} + 30$ $2.5 \times T_{C} + 80$ $2.5 \times T_{C} + 136$	46.8 96.8 152.8		ns
159	\overline{SS} deassertion to \overline{HREQ} output not deasserted (CPHA = 0)	Slave	_	$2.5 \times T_{C} + 30$	46.8	_	ns

Table 3-16 Serial Host Interface SPI Protocol Timing (continued)

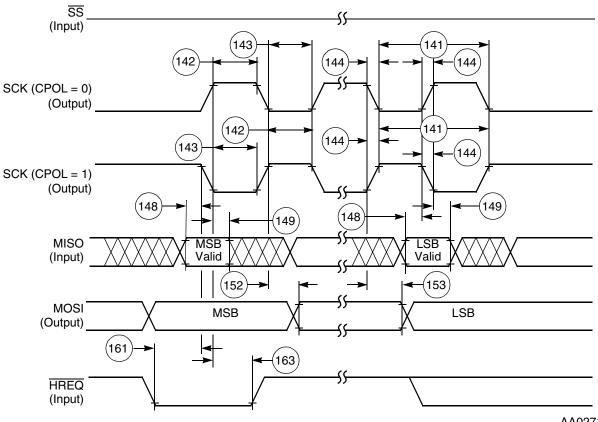
Serial Host Interface SPI Protocol Timing

No.	Characteristics ¹	Mode	Filter Mode	Expression ²	Min	Max	Unit
160	\overline{SS} deassertion pulse width (CPHA = 0)	Slave	_	T _C + 6	12.7	_	ns
161	HREQ in assertion to first SCK edge	Master	Bypassed Narrow Wide	$\begin{array}{l} 0.5 \times t_{SPICC} + 2.5 \times T_C + 43 \\ 0.5 \times t_{SPICC} + 2.5 \times T_C + 43 \\ 0.5 \times t_{SPICC} + 2.5 \times T_C + 43 \end{array}$	160.8		ns
162	HREQ in deassertion to last SCK sampling edge (HREQ in set-up time) (CPHA = 1)	Master		0	0		ns
163	First SCK edge to HREQ in not asserted (HREQ in hold time)	Master	_	0	0		ns

Table 3-16 Serial Host Interface SPI Protocol Timing (continued)

¹ $V_{CC} = 1.8 \text{ V} \pm 5\%$; $T_J = -40^{\circ}\text{C}$ to +95°C, $C_L = 50 \text{ pF}$ ² The timing values calculated are based on simulation data at 150MHz. Tester restrictions limit SHI testing to lower clock frequencies.

³ Periodically sampled, not 100% tested

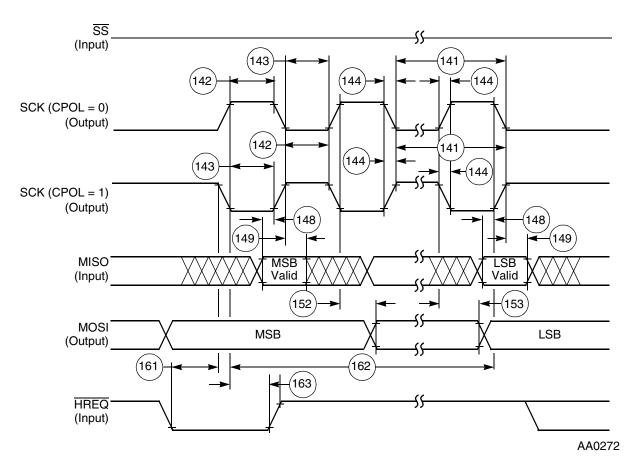


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Figure 3-27 SPI Master Timing (CPHA = 0)

DSP56367 Technical Data, Rev. 2.1

Serial Host Interface SPI Protocol Timing





DSP56367 Technical Data, Rev. 2.1

Serial Host Interface SPI Protocol Timing

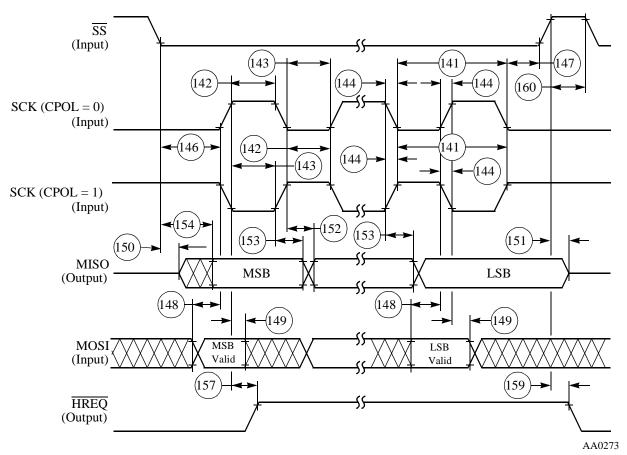


Figure 3-29 SPI Slave Timing (CPHA = 0)

3-41

Serial Host Interface (SHI) I²C Protocol Timing

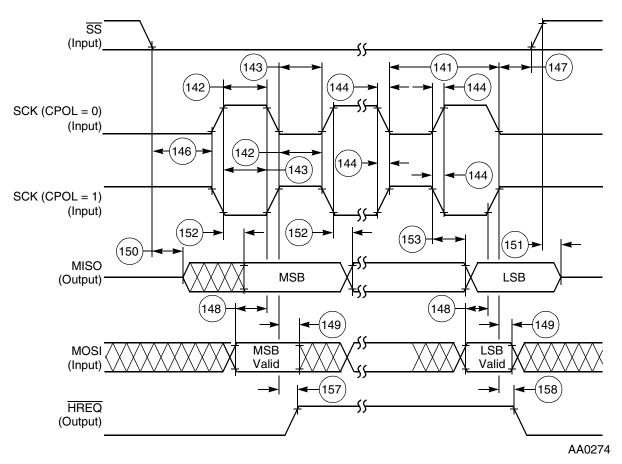


Figure 3-30 SPI Slave Timing (CPHA = 1)

3.13 Serial Host Interface (SHI) I²C Protocol Timing

Table 3-17 SHI I²C Protocol Timing

	Stan	dard I ² C					
Na	Characteristics ^{1, 2, 3}	Symbol/	Stand	ard ^{4,5}	Fast-Mode ^{5, 6}		Unit
No.		Expression	Min	Max	Min	Max	
	Tolerable spike width on SCL or SDA	_					ns
	Filters bypassed		—	0	—	0	
	Narrow filters enabled		—	50	—	50	
	Wide filters enabled		—	100	—	100	
171	SCL clock frequency	F _{SCL}	—	100	_	400	kHz
171	SCL clock cycle	T _{SCL}	10	_	2.5	—	μs
172	Bus free time	T _{BUF}	4.7	_	1.3	—	μs
173	Start condition set-up time	T _{SU;STA}	4.7	—	0.6	—	μs
174	Start condition hold time	T _{HD;STA}	4.0	—	0.6	—	μs

Serial Host Interface (SHI) I²C Protocol Timing

	Stand	lard I ² C					
Na	Characteristics ^{1, 2, 3}	Symbol/	Stand	ard ^{4,5}	Fast-Mode	5, 6	Unit
No.		Expression	Min	Мах	Min	Max	
175	SCL low period	T _{LOW}	4.7	—	1.3		μs
176	SCL high period	T _{HIGH}	4.0	—	1.3	_	μs
177	SCL and SDA rise time	т _R	—	1000	$20 + 0.1 \times C_b$	300	ns
178	SCL and SDA fall time	Т _F	—	300	$20 + 0.1 \times C_b$	300	ns
179	Data set-up time	T _{SU;DAT}	250	_	100		ns
180	Data hold time	T _{HD;DAT}	0.0	—	0.0	0.9	μs
181	DSP clock frequency • Filters bypassed • Narrow filters enabled • Wide filters enabled	F _{DSP}	10.6 11.8 13.1		28.5 39.7 61.0		MHz
182	SCL low to data out valid	T _{VD;DAT}	_	3.4	—	0.9	μs
183	Stop condition setup time	T _{SU;STO}	4.0	_	0.6		μs
184	HREQ in deassertion to last SCL edge (HREQ in set-up time)	t _{SU;RQI}	0.0		0.0		ns
186	 First SCL sampling edge to HREQ output deassertion² Filters bypassed Narrow filters enabled Wide filters enabled 	$T_{NG;RQO}$ $2 \times T_{C} + 30$ $2 \times T_{C} + 120$ $2 \times T_{C} + 208$		50 140 228	_ _ _	50 140 228	ns
187	Last SCL edge to HREQ output not deasserted ² Filters bypassed Narrow filters enabled Wide filters enabled 	$T_{AS;RQO}$ $2 \times T_{C} + 30$ $2 \times T_{C} + 80$ $2 \times T_{C} + 135$	50 100 155		50 100 155		ns
188	HREQ in assertion to first SCL edgeFilters bypassedNarrow filters enabledWide filters enabled	T _{AS;RQI} 0.5 × T _I 2 _{CCP} - 0.5 × T _C - 21	4327 4282 4238		927 882 838		ns
187	First SCL edge to HREQ in not asserted (HREQ in hold time.)	^t HO;RQI	0.0	—	0.0	—	ns

Table 3-17 SHI I²C Protocol Timing (continued)

¹ $V_{CC} = 1.8 \text{ V} \pm 5\%$; $T_{J} = -40^{\circ}\text{C}$ to +95°C, $C_{L} = 50 \text{ pF}$

² Pull-up resistor: $R_{P (min)} = 1.5$ kOhm

³ Capacitive load: $C_{b (max)} = 400 \text{ pF}$

⁴ It is recommended to enable the wide filters when operating in the I²C Standard Mode.

⁵ The timing values are derived from frequencies not exceeding 100 MHz.

⁶ It is recommended to enable the narrow filters when operating in the I²C Fast Mode.

DSP56367 Technical Data, Rev. 2.1

Serial Host Interface (SHI) I²C Protocol Timing

3.13.1 Programming the Serial Clock

The programmed serial clock cycle, T_{I^2CCP} , is specified by the value of the HDM[7:0] and HRS bits of the HCKR (SHI clock control register).

The expression for T_{I^2CCP} is

$$\Gamma_{I^{2}CCP} = [T_{C} \times 2 \times (HDM[7:0] + 1) \times (7 \times (1 - HRS) + 1)]$$

where

HRS is the prescaler rate select bit. When HRS is cleared, the fixed divide-by-eight prescaler is operational. When HRS is set, the prescaler is bypassed.

HDM[7:0] are the divider modulus select bits. A divide ratio from 1 to 256 (HDM[7:0] = \$00 to \$FF) may be selected.

In I^2C mode, the user may select a value for the programmed serial clock cycle from

 $6 \times T_C$ (if HDM[7:0] = \$02 and HRS = 1)

to

 $4096 \times T_{C}$ (if HDM[7:0] = \$FF and HRS = 0)

The programmed serial clock cycle (T_{I^2CCP}), SCL rise time (T_R), and the filters selected should be chosen in order to achieve the desired SCL serial clock cycle (T_{SCL}), as shown in Table 3-18.

Table 3-18 SCL Serial Clock Cycle (T_{SCL}) Generated as Master

Filters bypassed	T_{I^2CCP} + 2.5 × T_C + 45ns + T_R
Narrow filters enabled	T_{I^2CCP} + 2.5 × T_C + 135ns + T_R
Wide filters enabled	T_{I^2CCP} + 2.5 × T_C + 223ns + T_R

EXAMPLE:

For DSP clock frequency of 100 MHz (i.e. $T_C = 10ns$), operating in a standard mode I²C environment ($F_{SCL} = 100 \text{ kHz}$ (i.e. $T_{SCL} = 10\mu s$), $T_R = 1000ns$), with wide filters enabled:

$$T_{I^2CCP} = 10\mu s - 2.5 \times 10ns - 223ns - 1000ns = 8752ns$$

Choosing HRS = 0 gives

HDM[7:0] =
$$(8752ns)/(2 \times 10ns \times 8) - 1 = 53.7$$

Thus the HDM[7:0] value should be programmed to \$36 (=54).

The resulting T_{I^2CCP} will be:

$$T_{I^{2}CCP} = [T_{C} \times 2 \times (HDM[7:0] + 1) \times (7 \times (1 - 0) + 1)]$$
$$T_{I^{2}CCP} = [10ns \times 2 \times (54 + 1) \times (7 \times (1 - 0) + 1)]$$
$$T_{I^{2}CCP} = [10ns \times 2 \times 54 \times 8] = 8640ns$$

DSP56367 Technical Data, Rev. 2.1

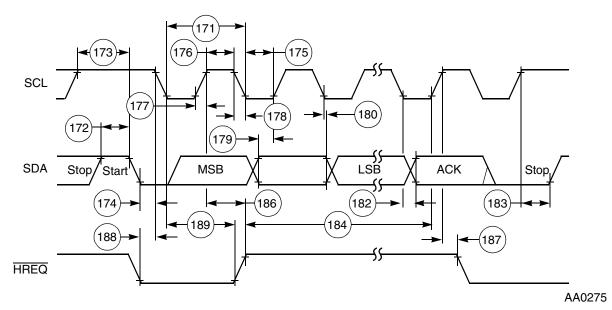


Figure 3-31 I²C Timing

3.14 Enhanced Serial Audio Interface Timing

No.	Characteristics ^{3, 4, 5}	Symbol	Expression	Min	Max	Condition ⁶	Unit
430	Clock cycle ⁷	t _{SSICC}	$4 \times T_{C}$	26.8	_	i ck	ns
			$3 \times T_{C}$	20.1	—	x ck	
			TXC:max[3*tc; t454]	26.5	-	x ck	
431	Clock high period	_					ns
	For internal clock		$2 \times T_{C} - 10.0$	3.4	_		
	For external clock		$1.5 imes T_C$	10.0	—		
432	Clock low period	_					ns
	For internal clock		$2 \times T_{C} - 10.0$	3.4	—		
	For external clock		$1.5 imes T_C$	10.0	—		
433	RXC rising edge to FSR out (bl) high	_	_	_	37.0	x ck	ns
				—	22.0	i ck a	
434	RXC rising edge to FSR out (bl) low	_	—	_	37.0	x ck	ns
				_	22.0	i ck a	
435	RXC rising edge to FSR out (wr) high ⁸	_	_	_	39.0	x ck	ns
				_	24.0	i ck a	
436	RXC rising edge to FSR out (wr) low ⁸				39.0	x ck	ns
	-			_	24.0	i ck a	

 Table 3-19 Enhanced Serial Audio Interface Timing^{1, 2}

DSP56367 Technical Data, Rev. 2.1

Enhanced Serial Audio Interface Timing

No	Characteristics ^{3, 4, 5}	Symbol	Everacion	Min	Max	Condition ⁶	Unit
No.		Symbol	Expression	Min	Мах	Condition	Unit
437	RXC rising edge to FSR out (wl) high	—	—	—	36.0	x ck	ns
					21.0	i ck a	
438	RXC rising edge to FSR out (wl) low	—	—	_	37.0	x ck	ns
				—	22.0	i ck a	
439	Data in setup time before RXC (SCK in synchronous	_		0.0	_	x ck	ns
	mode) falling edge			19.0	—	i ck	
440	Data in hold time after RXC falling edge	_		5.0	_	x ck	ns
	5 5			3.0	_	i ck	
441	FSR input (bl, wr) high before RXC falling edge ⁸			23.0	_	x ck	ns
				1.0	_	i ck a	110
442	FSR input (wl) high before RXC falling edge			23.0		x ck	ns
442	ron input (wi) high before hac talling edge	_		1.0		i ck a	115
443	FSR input hold time after RXC falling edge	—	_	3.0	_	x ck	ns
				0.0	_	i ck a	
444	Flags input setup before RXC falling edge	—	—	0.0	—	x ck	ns
				19.0	—	i ck s	
445	Flags input hold time after RXC falling edge	—		6.0	—	x ck	ns
				0.0	_	ick s	
446	TXC rising edge to FST out (bl) high	—	—	—	29.0	x ck	ns
				—	15.0	i ck	
447	TXC rising edge to FST out (bl) low	_			31.0	x ck	ns
					17.0	i ck	
448	TXC rising edge to FST out (wr) high ⁸	_			31.0	x ck	ns
				_	17.0	i ck	
449	TXC rising edge to FST out (wr) low ⁸			_	33.0	x ck	ns
				_	19.0	i ck	
450	TXC rising edge to FST out (wl) high				30.0	x ck	ns
-50	The maining edge to For out (wi) high				16.0	i ck	115
451	TXC rising adds to EST out (with low						
451	TXC rising edge to FST out (wl) low		_		31.0 17.0	x ck i ck	ns
452	TXC rising edge to data out enable from high impedance	-	_	-	31.0	x ck	ns
					17.0	i ck	
453	TXC rising edge to transmitter #0 drive enable	-	—	—	34.0	x ck	ns
	assertion			—	20.0	i ck	

 Table 3-19 Enhanced Serial Audio Interface Timing^{1, 2} (continued)

No.	Characteristics ^{3, 4, 5}	Symbol	Expression	Min	Мах	Condition ⁶	Unit
-			•		26.5		
454	TXC rising edge to data out valid	_	23 + 0.5 × T _C 21.0		20.5 21.0	x ck i ck	ns
			21.0		-	_	
455	TXC rising edge to data out high impedance ⁹	—	—	—	31.0	x ck	ns
				_	16.0	i ck	
456	TXC rising edge to transmitter #0 drive enable deassertion ⁹	—	—	—	34.0	x ck	ns
				—	20.0	i ck	
457	FST input (bl, wr) setup time before TXC falling edge ⁸	_	—	2.0	_	x ck	ns
				21.0	—	i ck	
458	FST input (wl) to data out enable from high impedance	—	_		27.0	_	ns
459	FST input (wl) to transmitter #0 drive enable assertion	—	_	_	31.0	—	ns
460	FST input (wl) setup time before TXC falling edge	_	_	2.0	—	x ck	ns
				21.0	—	i ck	
461	FST input hold time after TXC falling edge	_		4.0	_	x ck	ns
				0.0	_	i ck	
462	Flag output valid after TXC rising edge	_	_	_	32.0	x ck	ns
				—	18.0	i ck	
463	HCKR/HCKT clock cycle	_	—	40.0			ns
464	HCKT input rising edge to TXC output	_			27.5		ns
465	HCKR input rising edge to RXC output				27.5		ns

Table 3-19 Enhanced Serial Audio Interface Timing^{1, 2} (continued)

¹ The timing values calculated are based on simulation data at 150MHz. Tester restrictions limit ESAI testing to lower clock frequencies.

² ESAI_1 specs match those of ESAI_0.

³ $V_{CC} = 1.8 V \pm 5\%$; $T_{J} = -40^{\circ}C$ to $+95^{\circ}C$, $C_{L} = 50 \text{ pF}$

⁴ i ck = internal clock

x ck = external clock

i ck a = internal clock, asynchronous mode (asynchronous implies that TXC and RXC are two different clocks) i ck s = internal clock, synchronous mode (synchronous implies that TXC and RXC are the same clock)

⁵ bl = bit length

wl = word length

wr = word length relative

 ⁶ TXC(SCKT pin) = transmit clock RXC(SCKR pin) = receive clock FST(FST pin) = transmit frame sync FSR(FSR pin) = receive frame sync HCKT(HCKT pin) = transmit high frequency clock HCKR(HCKR pin) = receive high frequency clock

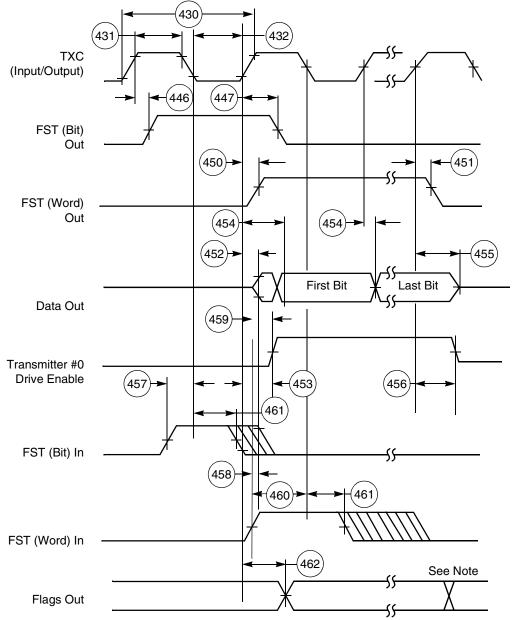
⁷ For the internal clock, the external clock cycle is defined by Icyc and the ESAI control register.

DSP56367 Technical Data, Rev. 2.1

3-47

Enhanced Serial Audio Interface Timing

- ⁸ The word-relative frame sync signal waveform relative to the clock operates in the same manner as the bit-length frame sync signal waveform, but spreads from one serial clock before first bit clock (same as bit length frame sync signal), until the one before last bit clock of the first word in frame.
- ⁹ Periodically sampled and not 100% tested.

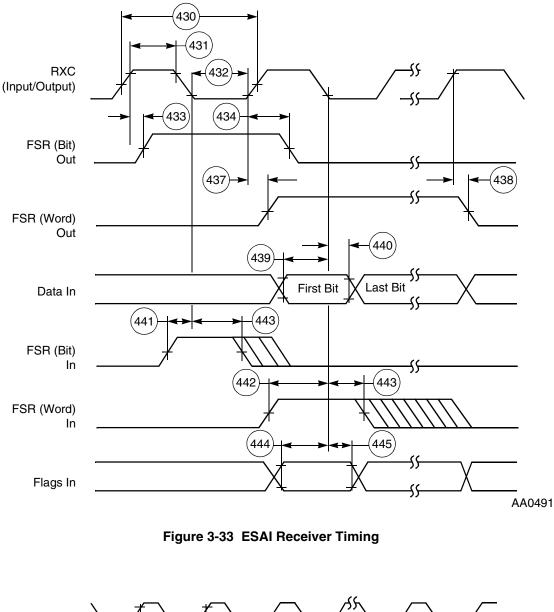


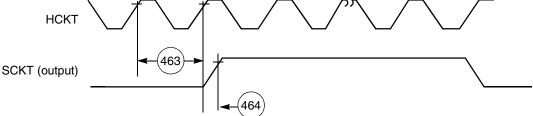
Note: In network mode, output flag transitions can occur at the start of each time slot within the frame. In normal mode, the output flag state is asserted for the entire frame period.

AA0490



DSP56367 Technical Data, Rev. 2.1







DSP56367 Technical Data, Rev. 2.1

Digital Audio Transmitter Timing

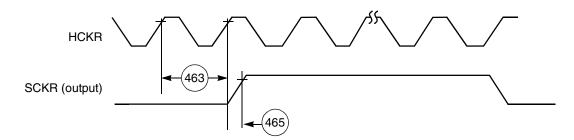


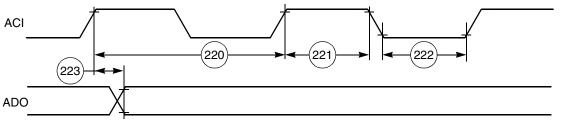
Figure 3-35 ESAI HCKR Timing

3.15 Digital Audio Transmitter Timing

Table 3-20 Digital Audio Transmitter Timing

No.	Characteristic	Expression	150	Unit	
	Characteristic	Expression	Min	Max	Onit
	ACI frequency ¹	1 / (2 x T _C)	—	75	MHz
220	ACI period	$2 \times T_{C}$	13.4	—	ns
221	ACI high duration	$0.5 imes T_{C}$	3.4	_	ns
222	ACI low duration	$0.5 imes T_{C}$	3.4	_	ns
223	ACI rising edge to ADO valid	$1.5 imes T_C$	—	10.0	ns

In order to assure proper operation of the DAX, the ACI frequency should be less than 1/2 of the DSP56367 internal clock frequency. For example, if the DSP56367 is running at 150 MHz internally, the ACI frequency should be less than 75 MHz.



AA1280

Figure 3-36 Digital Audio Transmitter Timing

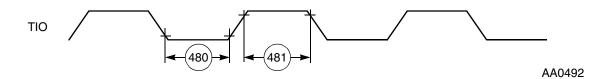
1

Timer Timing 3.16

Table 3-21 Timer Timing	1
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No.	Characteristics	Expression	150	Unit		
NO.	Characteristics	Expression	Min	Мах	Onit	
480	TIO Low	$2 \times T_{C} + 2.0$	15.4	_	ns	
481	TIO High	$2 \times T_{C} + 2.0$	15.4	_	ns	

¹ V_{CC} = 1.8 V \pm 0.09 V; T_J = -40°C to +95°C, C_L = 50 pF





GPIO Timing 3.17

Table 3-22 GPIO Timing

No.	Characteristics ¹	Expression	Min	Max	Unit
490 ²	EXTAL edge to GPIO out valid (GPIO out delay time)		_	32.8	ns
491	EXTAL edge to GPIO out not valid (GPIO out hold time)		4.8	_	ns
492	GPIO In valid to EXTAL edge (GPIO in set-up time)		10.2	_	ns
493	EXTAL edge to GPIO in not valid (GPIO in hold time)		1.8	_	ns
494 ²	Fetch to EXTAL edge before GPIO change	6.75 × T _C -1.8	43.4	_	ns
495	GPIO out rise time	_	_	13	ns
496	GPIO out fall time	_	_	13	ns

 $\begin{array}{c} \hline 1 \quad V_{CC} = 1.8 \text{ V} \pm 0.09 \text{ V}; \ T_{J} = -40^{\circ}\text{C to } +95^{\circ}\text{C}, \ C_{L} = 50 \text{ pF} \\ \hline 2 \quad \text{Valid only when PLL enabled with multiplication factor equal to one.} \end{array}$

DSP56367 Technical Data, Rev. 2.1

3-51

JTAG Timing

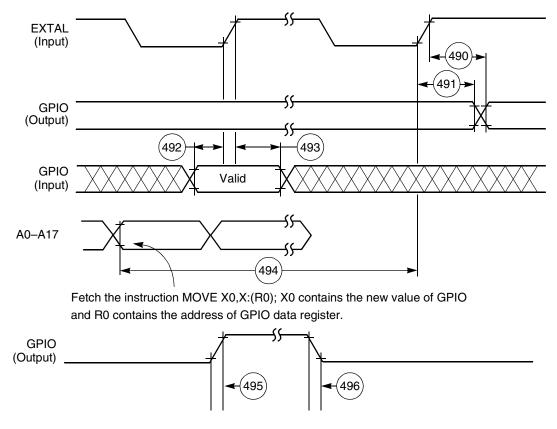


Figure 3-38 GPIO Timing

3.18 JTAG Timing

Table 3-23	JTAG Timing ^{1, 2}
------------	-----------------------------

No.	Characteristics	All freq	Unit	
140.	Characteristics	Min	Max	Onit
500	TCK frequency of operation $(1/(T_C \times 3); maximum 22 MHz)$	0.0	22.0	MHz
501	TCK cycle time in Crystal mode	45.0	_	ns
502	TCK clock pulse width measured at 1.5 V	20.0	_	ns
503	TCK rise and fall times	0.0	3.0	ns
504	Boundary scan input data setup time	5.0	_	ns
505	Boundary scan input data hold time	24.0	_	ns
506	TCK low to output data valid	0.0	40.0	ns
507	TCK low to output high impedance	0.0	40.0	ns
508	TMS, TDI data setup time	5.0	_	ns

No.	Characteristics	All freq	Unit	
NO.	Characteristics	Min	Max	onn
509	TMS, TDI data hold time	25.0	_	ns
510	TCK low to TDO data valid	0.0	44.0	ns
511	TCK low to TDO high impedance	0.0	44.0	ns

Table 3-23 JTAG Timing^{1, 2} (continued)

¹ $V_{CC} = 1.8 \text{ V} \pm 0.09 \text{ V}; T_J = -40^{\circ}\text{C} \text{ to } +95^{\circ}\text{C}, C_L = 50 \text{ pF}$ ² All timings apply to OnCE module data transfers because it uses the JTAG port as an interface.

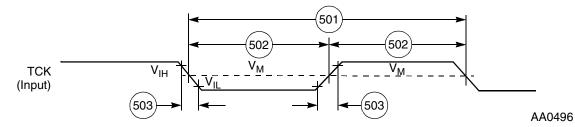


Figure 3-39 Test Clock Input Timing Diagram

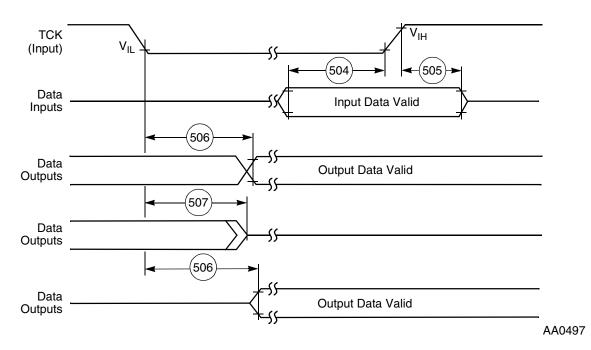


Figure 3-40 Boundary Scan (JTAG) Timing Diagram

DSP56367 Technical Data, Rev. 2.1

Freescale Semiconductor

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JTAG Timing

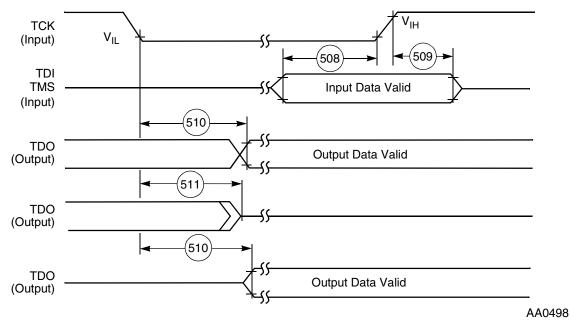


Figure 3-41 Test Access Port Timing Diagram

4 Packaging

4.1 Pin-out and Package Information

This section provides information about the available package for this product, including diagrams of the package pinouts and tables describing how the signals described in **Section 1** are allocated for the package. The DSP56367 is available in a 144-pin LQFP package. Table 4-1and Table 4-2 show the pin/name assignments for the packages.

4.1.1 LQFP Package Description

Top view of the 144-pin LQFP package is shown in Figure 4-1 with its pin-outs. The package drawing is shown in Figure 4-2.

Pin-out and Package Information

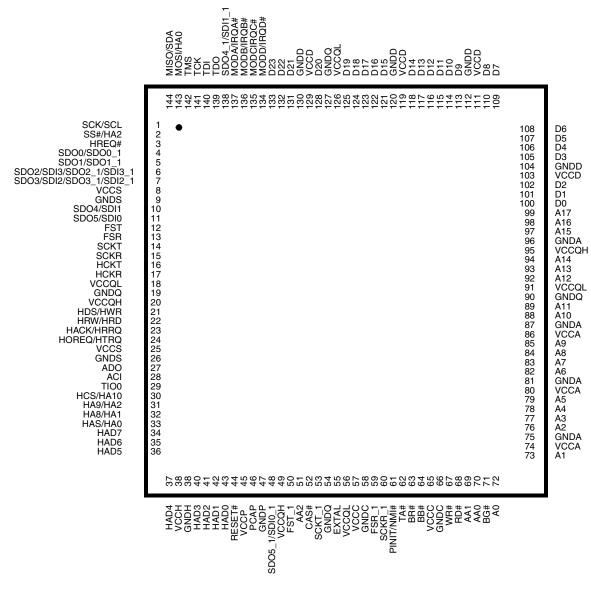


Figure 4-1 144-pin package

Pin-out and Package Information

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
A0	72	D9	113	GNDS	9	SDO0/SDO0_1	4
A1	73	D10	114	GNDS	26	SDO1/SDO1_1	5
A2	76	D11	115	HA8/HA1	32	SDO2/SDI3/SDO2_1/SDI3_1	6
A3	77	D12	116	HA9/HA2	31	SDO3/SDI2/SDO3_1/SDI2_1	7
A4	78	D13	117	HACK/HRRQ	23	SDO4/SDI1	10
A5	79	D14	118	HAD0	43	SDO4_1/SDI1_1	138
A6	82	D15	121	HAD1	42	SDO5/SDI0	11
A7	83	D16	122	HAD2	41	SDO5_1/SDI0_1	48
A8	84	D17	123	HAD3	40	SS#/HA2	2
A9	85	D18	124	HAD4	37	TA#	62
A10	88	D19	125	HAD5	36	ТСК	141
A11	89	D20	128	HAD6	35	TDI	140
A12	92	D21	131	HAD7	34	TDO	139
A13	93	D22	132	HAS/HA0	33	TIO0	29
A14	94	D23	133	HCKR	17	TMS	142
A15	97	EXTAL	55	НСКТ	16	VCCA	74
A16	98	FSR	13	HCS/HA10	30	VCCA	80
A17	99	FSR_1	59	HDS/HWR	21	VCCA	86
AA0	70	FST	12	HOREQ/HTRQ	24	VCCC	57
AA1	69	FST_1	50	HREQ#	3	VCCC	65
AA2	51	GNDA	75	HRW/HRD	22	VCCD	103
ACI	28	GNDA	81	MODA/IRQA#	137	VCCD	111
ADO	27	GNDA	87	MODB/IRQB#	136	VCCD	119
BB#	64	GNDA	96	MODC/IRQC#	135	VCCD	129
BG#	71	GNDC	58	MODD/IRQD#	134	VCCH	38
BR#	63	GNDC	66	MISO/SDA	144	VCCQH	20
CAS#	52	GNDD	104	MOSI/HA0	143	VCCQH	95
D0	100	GNDD	112	PCAP	46	VCCQH	49
D1	101	GNDD	120	PINIT/NMI#	61	VCCQL	18
D2	102	GNDD	130	RD#	68	VCCQL	56
D3	105	GNDH	39	RESET#	44	VCCQL	91
D4	106	GNDP	47	SCK/SCL	1	VCCQL	126
D5	107	GNDQ	19	SCKR	15	VCCP	45
D6	108	GNDQ	54	SCKR_1	60	VCCS	8
D7	109	GNDQ	90	SCKT	14	VCCS	25
D8	110	GNDQ	127	SCKT_1	53	WR#	67

Table 4-1 Signal Identification by N	Name
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DSP56367 Technical Data, Rev. 2.1

4-3

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
1	SCK/SCL	37	HAD4	73	A1	109	D7
2	SS#/HA2	38	VCCH	74	VCCA	110	D8
3	HREQ#	39	GNDH	75	GNDA	111	VCCD
4	SDO0/SDO0_1	40	HAD3	76	A2	112	GNDD
5	SDO1/SDO1_1	41	HAD2	77	A3	113	D9
6	SDO2/SDI3/SDO2_1/SDI3_1	42	HAD1	78	A4	114	D10
7	SDO3/SDI2/SDO3_1/SDI2_1	43	HAD0	79	A5	115	D11
8	VCCS	44	RESET#	80	VCCA	116	D12
9	GNDS	45	VCCP	81	GNDA	117	D13
10	SDO4/SDI1	46	PCAP	82	A6	118	D14
11	SDO5/SDI0	47	GNDP	83	A7	119	VCCD
12	FST	48	SDO5_1/SDI0_1	84	A8	120	GNDD
13	FSR	49	VCCQH	85	A9	121	D15
14	SCKT	50	FST_1	86	VCCA	122	D16
15	SCKR	51	AA2	87	GNDA	123	D17
16	НСКТ	52	CAS#	88	A10	124	D18
17	HCKR	53	SCKT_1	89	A11	125	D19
18	VCCQL	54	GNDQ	90	GNDQ	126	VCCQL
19	GNDQ	55	EXTAL	91	VCCQL	127	GNDQ
20	VCCQH	56	VCCQL	92	A12	128	D20
21	HDS/HWR	57	VCCC	93	A13	129	VCCD
22	HRW/HRD	58	GNDC	94	A14	130	GNDD
23	HACK/HRRQ	59	FSR_1	95	VCCQH	131	D21
24	HOREQ/HTRQ	60	SCKR_1	96	GNDA	132	D22
25	VCCS	61	PINIT/NMI#	97	A15	133	D23
26	GNDS	62	TA#	98	A16	134	MODD/IRQD#
27	ADO	63	BR#	99	A17	135	MODC/IRQC#
28	ACI	64	BB#	100	D0	136	MODB/IRQB#
29	TIO0	65	VCCC	101	D1	137	MODA/IRQA#
30	HCS/HA10	66	GNDC	102	D2	138	SDO4_1/SDI1_1
31	HA9/HA2	67	WR#	103	VCCD	139	TDO
32	HA8/HA1	68	RD#	104	GNDD	140	TDI
33	HAS/HA0	69	AA1	105	D3	141	тск
34	HAD7	70	AA0	106	D4	142	TMS
35	HAD6	71	BG#	107	D5	143	MOSI/HA0
36	HAD5	72	A0	108	D6	144	MISO/SDA

 Table 4-2
 Signal Identification by Pin Number

4.1.2 LQFP Package Mechanical Drawing

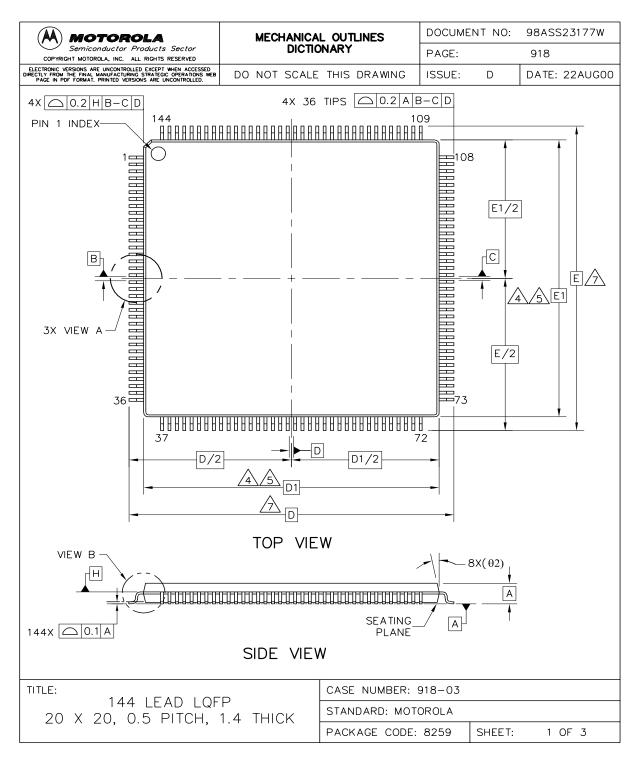


Figure 4-2 DSP56367 144-pin LQFP Package (1 of 3)

DSP56367 Technical Data, Rev. 2.1

Pin-out and Package Information

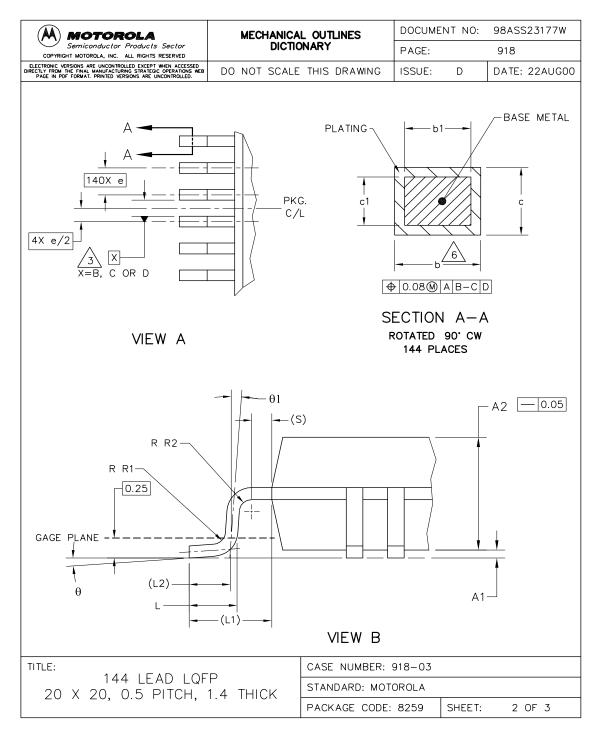


Figure 4-3 DSP56367 144-pin LQFP Package (2 of 3)

		MECHANICAL OUTLINES		DOCUM	ENT NO:	98ASS	S23177W	
COPY	Semiconductor Products Sector RIGHT MOTOROLA, INC. ALL RIGHTS RESERVED		DICTIONARY			PAGE:		
ELECTRONIC DIRECTLY FRO PAGE IN	VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED IN THE FINAL MANUFACTURING STRATEGIC OPERATIONS WEB PDF FORMAT. PRINTED VERSIONS ARE UNCONTROLLED.	DO NOT S	CALE THIS D	RAWING	ISSUE:	D	DATE:	22AUG00
NOT	ES:							
1.	ALL DIMENSIONS ARE IN	MILLIMETER	25					
					514 400			
2. ∧	INTERPRET DIMENSIONS A	ND TOLERAN	NCES PER A	SME Y14.	5M-199	4.		
$\overline{3.}$	DATUMS B, C AND D TO E	BE DETERMIN	NED AT DATI	um plane	Е Н.			
	THE TOP PACKAGE BODY S MAXIMUM OF 0.1 mm.	SIZE MAY BE	SMALLER	than the	Е ВОТТО	М РАСКА	GE SIZ	E BY A
	DIMENSIONS D1 AND E1 D ALLOWABLE PROTRUSION I SIZE DIMENSIONS INCLUD	S 0.25 mm	PER SIDE.			THE MAX E MAXIM		γ
6.	DIMENSION b DOES NOT I CAUSE THE LEAD WIDTH T AND AN ADJACENT LEAD S	NCLUDE DAM	M BAR PROTI D. 35. MIN	RUSION. IMUM SP <i>i</i>		USIONS : WEEN PR		
\wedge	AND AN ADJACENT LEAD S	MALL BE U.	U7 MM.					
<u> </u>	DIMENSIONS D AND E ARE	DETERMINE	ED AT THE	SEATING	PLANE,	DATUM	Α.	
DIM	MIN MAX	DIM	MIN	MAX	DIM	MIN		MAX
A	1.6	L1	- 1 REF	_	-	-	-	-
A1	0.05 - 0.15	L2	- 0.5 REF	_	-	-	-	-
A2	1.35 – 1.45	R1 C).13 –	0.2	-	_	-	-
b	0.17 – 0.27).13 –	_	-	_	-	-
b1	0.17 – 0.23	S	- 0.25 REF		-	-	-	-
с	0.09 - 0.20	θ	0. –	7.	-	-	-	-
c1	0.09 - 0.16	θ1	0. –	-	-	-	-	-
D	– 22 BSC –	θ2	– 12' REF	-	-	-	-	-
D1	- 20 BSC -	-		-	-	-	-	-
е	- 0.5 BSC -	-		-	-	-	-	-
E	- 22 BSC -	-		-	-	-	-	-
E1	- 20 BSC -	-		_	-	-	-	-
L	0.45 - 0.75	-		_	-	-	-	-
TITLE:			CASE	NUMBER:	918-03			
γ	144 LEAD LQF		, STAND	ARD: MOT	OROLA			
20) X 20, 0.5 PITCH,	1.4 IHICK		GE CODE:	8259	SHEET:	,3	OF 3
					5200		5	2. 3

Figure 4-4 DSP56367 144-pin LQFP Package (3 of 3)

Pin-out and Package Information

5 Design Considerations

5.1 Thermal Design Considerations

An estimation of the chip junction temperature, T_J, in °C can be obtained from the following equation:

$$\mathbf{T}_{\mathbf{J}} = \mathbf{T}_{\mathbf{A}} + (\mathbf{P}_{\mathbf{D}} \times \mathbf{R}_{\mathbf{\theta} \mathbf{J} \mathbf{A}})$$

Where:

 $\begin{array}{ll} T_A &= \mbox{ambient temperature }^\circ C \\ R_{qJA} &= \mbox{package junction-to-ambient thermal resistance }^\circ C/W \\ P_D &= \mbox{power dissipation in package W} \end{array}$

Historically, thermal resistance has been expressed as the sum of a junction-to-case thermal resistance and a case-to-ambient thermal resistance.

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$$

Where:

 $R_{\theta IA}$ = package junction-to-ambient thermal resistance °C/W

 $R_{\theta IC}$ = package junction-to-case thermal resistance °C/W

 $R_{\theta CA}$ = package case-to-ambient thermal resistance °C/W

 $R_{\theta JC}$ is device-related and cannot be influenced by the user. The user controls the thermal environment to change the case-to-ambient thermal resistance, $R_{\theta CA}$. For example, the user can change the air flow around the device, add a heat sink, change the mounting arrangement on the printed circuit board (PCB), or otherwise change the thermal dissipation capability of the area surrounding the device on a PCB. This model is most useful for ceramic packages with heat sinks; some 90% of the heat flow is dissipated through the case to the heat sink and out to the ambient environment. For ceramic packages, in situations where the heat flow is split between a path to the case and an alternate path through the PCB, analysis of the device thermal performance may need the additional modeling capability of a system level thermal simulation tool.

The thermal performance of plastic packages is more dependent on the temperature of the PCB to which the package is mounted. Again, if the estimations obtained from $R_{\theta JA}$ do not satisfactorily answer whether the thermal performance is adequate, a system level model may be appropriate.

A complicating factor is the existence of three common ways for determining the junction-to-case thermal resistance in plastic packages.

DSP56367 Technical Data, Rev. 2.1

Electrical Design Considerations

- To minimize temperature variation across the surface, the thermal resistance is measured from the junction to the outside surface of the package (case) closest to the chip mounting area when that surface has a proper heat sink.
- To define a value approximately equal to a junction-to-board thermal resistance, the thermal resistance is measured from the junction to where the leads are attached to the case.
- If the temperature of the package case (T_T) is determined by a thermocouple, the thermal resistance is computed using the value obtained by the equation: $(T_J T_T)/P_D$.

As noted above, the junction-to-case thermal resistances quoted in this data sheet are determined using the first definition. From a practical standpoint, that value is also suitable for determining the junction temperature from a case thermocouple reading in forced convection environments. In natural convection, using the junction-to-case thermal resistance to estimate junction temperature from a thermocouple reading on the case of the package will estimate a junction temperature slightly hotter than actual temperature. Hence, the new thermal metric, thermal characterization parameter or Ψ_{JT} , has been defined to be $(T_J - T_T)/P_D$. This value gives a better estimate of the junction temperature in natural convection when using the surface temperature of the package. Remember that surface temperature readings of packages are subject to significant errors caused by inadequate attachment of the sensor to the surface and to errors caused by heat loss to the sensor. The recommended technique is to attach a 40-gauge thermocouple wire and bead to the top center of the package with thermally conductive epoxy.

5.2 Electrical Design Considerations

CAUTION

This device contains circuitry protecting against damage due to high static voltage or electrical fields. However, normal precautions should be taken to avoid exceeding maximum voltage ratings. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). The suggested value for a pull-up or pull-down resistor is 10 k ohm.

Use the following list of recommendations to assure correct DSP operation:

- Provide a low-impedance path from the board power supply to each V_{CC} pin on the DSP and from the board ground to each GND pin.
- Use at least six 0.01–0.1 μ F bypass capacitors positioned as close as possible to the four sides of the package to connect the V_{CC} power source to GND.
- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V_{CC} and GND pins are less than 1.2 cm (0.5 inch) per capacitor lead.
- Use at least a four-layer PCB with two inner layers for V_{CC} and GND.
- Because the DSP output signals have fast rise and fall times, PCB trace lengths should be minimal. This recommendation particularly applies to the address and data buses as well as the IRQA, IRQB, IRQD, and TA pins. Maximum PCB trace lengths on the order of 15 cm (6 inches) are recommended.

- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance. This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V_{CC} and GND circuits.
- All inputs must be terminated (i.e., not allowed to float) using CMOS levels, except for the three pins with internal pull-up resistors (TMS, TDI, TCK).
- Take special care to minimize noise levels on the V_{CCP} and GND_P pins.
- If multiple DSP56367 devices are on the same board, check for cross-talk or excessive spikes on the supplies due to synchronous operation of the devices.
- RESET must be asserted when the chip is powered up. A stable EXTAL signal must be supplied before deassertion of RESET.
- At power-up, ensure that the voltage difference between the 3.3 V tolerant pins and the chip V_{CC} never exceeds a TBD voltage.

5.3 **Power Consumption Considerations**

Power dissipation is a key issue in portable DSP applications. Some of the factors which affect current consumption are described in this section. Most of the current consumed by CMOS devices is alternating current (ac), which is charging and discharging the capacitances of the pins and internal nodes.

Current consumption is described by the following formula:

$$\mathbf{I} = \mathbf{C} \times \mathbf{V} \times \mathbf{f}$$

where:

C = node/pin capacitance

V = voltage swing

f = frequency of node/pin toggle

Example 1. Power Consumption

For a Port A address pin loaded with 50 pF capacitance, operating at 3.3 V, and with a 100 MHz clock, toggling at its maximum possible rate (50 MHz), the current consumption is

$$I = 50 \times 10^{-12} \times 3.3 \times 50 \times 10^{6} = 8.25 \text{ mA}$$

The maximum internal current (I_{CCI} max) value reflects the typical possible switching of the internal buses on best-case operation conditions, which is not necessarily a real application case. The typical internal current (I_{CCItvp}) value reflects the average switching of the internal buses on typical operating conditions.

For applications that require very low current consumption, do the following:

- Set the EBD bit when not accessing external memory.
- Minimize external memory accesses and use internal memory accesses.
- Minimize the number of pins that are switching.
- Minimize the capacitive load on the pins.
- Connect the unused inputs to pull-up or pull-down resistors.
- Disable unused peripherals.

DSP56367 Technical Data, Rev. 2.1

PLL Performance Issues

One way to evaluate power consumption is to use a current per MIPS measurement methodology to minimize specific board effects (i.e., to compensate for measured board current not caused by the DSP). A benchmark power consumption test algorithm is listed in Appendix A, "Power Consumption Benchmark". Use the test algorithm, specific test current measurements, and the following equation to derive the current per MIPS value.

$$I/MIPS = I/MHz = (I_{typF2} - I_{typF1})/(F2 - F1)$$

where:

$$\begin{split} I_{typF2} &= \text{current at F2} \\ I_{typF1} &= \text{current at F1} \\ F2 &= \text{high frequency (any specified operating frequency)} \\ F1 &= \text{low frequency (any specified operating frequency lower than F2)} \end{split}$$

NOTE

F1 should be significantly less than F2. For example, F2 could be 66 MHz and F1 could be 33 MHz. The degree of difference between F1 and F2 determines the amount of precision with which the current rating can be determined for an application.

5.4 PLL Performance Issues

The following explanations should be considered as general observations on expected PLL behavior. There is no testing that verifies these exact numbers. These observations were measured on a limited number of parts and were not verified over the entire temperature and voltage ranges.

5.4.1 Input (EXTAL) Jitter Requirements

The allowed jitter on the frequency of EXTAL is 0.5%. If the rate of change of the frequency of EXTAL is slow (i.e., it does not jump between the minimum and maximum values in one cycle) or the frequency of the jitter is fast (i.e., it does not stay at an extreme value for a long time), then the allowed jitter can be 2%. The phase and frequency jitter performance results are only valid if the input jitter is less than the prescribed values.

Appendix A Power Consumption Benchmark

The following benchmark program permits evaluation of DSP power usage in a test situation. It enables the PLL, disables the external clock, and uses repeated multiply-accumulate instructions with a set of synthetic DSP application data to emulate intensive sustained DSP operation.

```
;* ;* CHECKS Typical Power Consumption
200,55,0,0,0
        page
        nolist
I VEC EQU $000000
                 ; Interrupt vectors for program debug only
START EQU $8000
                 ; MAIN (external) program starting address
INT PROG EQU $100 ; INTERNAL program memory starting address
INT XDAT EQU $0 ; INTERNAL X-data memory starting address
INT YDAT EQU $0
                 ; INTERNAL Y-data memory starting address
        INCLUDE "ioequ.asm"
        INCLUDE "intequ.asm"
        list
                 P:START
        orq
;
        movep #$0123FF,x:M BCR; BCR: Area 3 : 1 w.s (SRAM)
; Default: 1 w.s (SRAM)
;
                 #$0d0000,x:M PCTL
                                            ; XTAL disable
        movep
                          ; PLL enable
                          ; CLKOUT disable
;
 Load the program
;
;
                 #INT PROG,r0
        move
        move
                 #PROG START, r1
                 #(PROG_END-PROG_START), PLOAD_LOOP
        do
        move
                 p:(r1)+,x0
        move
                 x0,p:(r0)+
        nop
PLOAD LOOP
;
; Load the X-data
;
                 #INT XDAT, r0
        move
                 #XDAT START,r1
        move
```

DSP56367 Technical Data, Rev. 2.1

	do move	p:(r1)+,x),XLOAD_I	JOOP
VI OND IO	move	x0,x:(r0)	+		
XLOAD_LOO	JE				
	he Y-data				
;					
	move	#INT_YDAT	',r0		
	move	#YDAT_STA	RT,rl		
	do		D-YDAT_START),YLOAD_I	JOOP
	move	p:(r1)+,x			
	move	x0,y:(r0)	+		
YLOAD_LOO	JP				
;					
	jmp	INT PROG			
	75	1111_11100			
PROG STAI	RT				
—	move	#\$0,r0			
	move	#\$0,r4			
	move	#\$3f,m0			
	move	#\$3f , m4			
;					
	clr	a			
	clr	b ##00			
	move	#\$0,x0			
	move	#\$0,x1 #\$0,y0			
	move	#\$0,y0 #\$0,y1			
	bset	#4,omr		; ebd	
;	2200	11 2 / 0112	,	0.00	
sbr	dor	#60, end			
	mac	x0,y0,a	x:(r0)+,x1		y:(r4)+,y1
	mac	x1,y1,a	x:(r0)+,x0		y:(r4)+,y0
	add	a,b			
	mac	x0,y0,a	x:(r0)+,x1		
	mac	x1,y1,a			y:(r4)+,y0
	move	b1,x:\$ff			
_end	bra	sbr			
	nop	SDI			
	nop				
	nop				
	nop				
PROG_END					
	nop				
	nop				
עדאם משאי	יייס				
XDAT_STAI	org	x:0			
i	dc	\$262EB9			
	dc	\$86F2FE			
	dc	\$E56A5F			
	dc	\$616CAC			
			DODECOC		

dc	\$8FFD75
dc	\$9210A
dc	\$A06D7B
dc	\$CEA798
dc	\$8DFBF1
dc	\$A063D6
dc	\$6C6657
dc	\$C2A544
dc	\$A3662D
dc	\$A4E762
dc	\$84F0F3
dc	\$E6F1B0
dc	•
dc	\$B3829
	\$8BF7AE
dc	\$63A94F
dc	\$EF78DC
dc	\$242DE5
dc	\$A3E0BA
dc	\$EBAB6B
dc	\$8726C8
dc	\$CA361
dc	\$2F6E86
dc	\$A57347
dc	\$4BE774
dc	\$8F349D
dc	\$A1ED12
dc	\$4BFCE3
dc	\$EA26E0
dc	\$CD7D99
dc	\$4BA85E
dc	\$27A43F
dc	\$A8B10C
dc	\$D3A55
dc	\$25EC6A
dc	\$2A255B
dc	\$A5F1F8
dc	\$2426D1
dc	\$AE6536
dc	\$CBBC37
dc	\$6235A4
dc	\$37F0D
dc	\$63BEC2
dc	\$A5E4D3
dc	\$8CE810
dc	\$3FF09
dc	\$60E50E
dc	\$CFFB2F
dc	\$40753C
dc	\$8262C5
dc	\$CA641A
dc	\$EB3B4B
dc	\$2DA928
dc	\$AB6641
dc	\$28A7E6
dc	\$4E2127
uc	YTDATA /

DSP56367 Technical Data, Rev. 2.1

dc	\$482FD4
dc	\$7257D
dc	\$E53C72
dc	\$1A8C3
dc	\$E27540
XDAT_END	

YDAT_START

;

AI_SIARI		
	org	y:0
	dc	\$5B6DA
	dc	\$C3F70B
	dc	
		\$6A39E8
	dc	\$81E801
	dc	\$C666A6
	dc	\$46F8E7
	dc	\$AAEC94
	dc	\$24233D
	dc	\$802732
	dc	\$2E3C83
	dc	•
		\$A43E00
	dc	\$C2B639
	dc	\$85A47E
	dc	\$ABFDDF
	dc	\$F3A2C
	dc	\$2D7CF5
	dc	\$E16A8A
	dc	\$ECB8FB
	dc	\$4BED18
	dc	\$43F371
	dc	\$83A556
	dc	\$E1E9D7
	dc	\$ACA2C4
	dc	\$8135AD
	dc	\$2CE0E2
	dc	\$8F2C73
	dc	\$432730
	dc	\$A87FA9
	dc	\$4A292E
	dc	
		\$A63CCF
	dc	\$6BA65C
	dc	\$E06D65
	dc	\$1AA3A
	dc	\$A1B6EB
	dc	\$48AC48
	dc	\$EF7AE1
	dc	\$6E3006
	dc	\$62F6C7
	dc	\$6064F4
		•
	dc	\$87E41D
	dc	\$CB2692
	dc	\$2C3863
	dc	\$C6BC60
	dc	\$43A519
	dc	\$6139DE
	dc	\$ADF7BF
	-	,

dc	\$4B3E8C
dc	\$6079D5
dc	\$E0F5EA
dc	\$8230DB
dc	\$A3B778
dc	\$2BFE51
dc	\$E0A6B6
dc	\$68FFB7
dc	\$28F324
dc	\$8F2E8D
dc	\$667842
dc	\$83E053
dc	\$A1FD90
dc	\$6B2689
dc	\$85B68E
dc	\$622EAF
dc	\$6162BC
dc	\$E4A245

YDAT_END

NOTES

Index

Α

ac electrical characteristics 4

В

Boundary Scan (JTAG Port) timing diagram 53 bus external address 4 external data 4

С

Clock 4 clock external 4 operation 5 clocks internal 4

D

DAX 18 dc electrical characteristics 3 design considerations electrical 3 PLL 4 power consumption 3 thermal 1 Digital Audio Transmitter 18 DRAM out of page wait states selection guide 21 write access 28 out of page and refresh timings 11 wait states 23 15 wait states 25 4 wait states 21 Page mode read accesses 20 wait states selection guide 15 write accesses 19 Page mode timings 3 wait states 16 4 wait states 17 refresh access 29 DSP56300 Family Manual 3

Е

electrical design considerations 3 Enhanced Serial Audio Interface 13, 16 ESAI 13, 16 receiver timing 49, 50 timings 45 transmitter timing 48 EXTAL jitter 4 external address bus 4 external bus control 4, 5, 6 external clock operation 4 external data bus 4 external interrupt timing (negative edge-triggered) 11 external level-sensitive fast interrupt timing 10 external memory access (DMA Source) timing 12 External Memory Expansion Port 4, 12

DSP56367 Technical Data, Rev. 2.1

F

functional signal groups 1

G

GPIO 18 GPIO timing 51 Ground 3

Η

HDI08 8, 10 HDI08 timing 31 Host Interface 8, 10 Host Interface timing 31

I

internal clocks 4 interrupt and mode control 6, 7 interrupt control 6, 7 interrupt timing 7 external level-sensitive fast 10 external negative edge-triggered 11

J

Jitter 4 JTAG 19 JTAG Port timing 52, 53

Μ

maximum ratings 1, 2 mode control 6, 7 Mode select timing 7 multiplexed bus timings read 35 write 36

Ν

non-multiplexed bus timings read 33 write 34

0

OnCE module 19 operating mode select timing 11

Ρ

package TQFP description 1, 4 Phase Lock Loop 6 PLL 4, 6 Characteristics 6 performance issues 4 PLL design considerations 4 PLL performance issues 4 Port A 4 Port A 4 Port B 9, 10 Port C 13, 16 Port D 18 Power 2 power consumption design considerations 3

R

recovery from Stop state using IRQA 11, 12 RESET 7 Reset timing 7, 10

S

Serial Host Interface 11 SHI 11 signal groupings 1 signals 1 SRAM read and write accesses 12 write access 14 Stop state recovery from 11, 12 Stop timing 7 supply voltage 2

Т

Test Access Port timing diagram 54 Test Clock (TCLK) input timing diagram 53 thermal characteristics 2 thermal design considerations 1 Timer 18 event input restrictions 51 timing 51 Timing Digital Audio Transmitter (DAX) 50 Enhanced Serial Audio Interface (ESAI) 48 General Purpose I/O (GPIO) Timing 45 OnCE[™] (On Chip Emulator) Timing 45 Serial Host Interface (SHI) SPI Protocol Timing 37 Serial Host Interface (SHI) Timing 37 timing

interrupt 7 mode select 7 Reset 7 Stop 7 TQFP pin list by number 4 pin-out drawing (top) 1

DSP56367 Technical Data, Rev. 2.1

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